LM61495, LM61480, LM62460

ZHCSN39 - FEBRUARY 2020



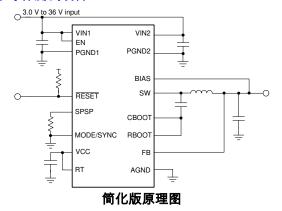
# 针对功率密度和低 EMI 进行了优化的 LM62460、LM61480 和 LM61495 引脚兼容 6A/8A/10A 降压转换器

### 1 特性

- 提供功能安全
  - 一 可帮助进行功能安全系统设计的文档
- 输入电压范围:3V至36V
- 具有滤波器和延迟释放的 RESET 输出
- 可实现低 EMI:
  - 符合 CISPR 11/32 B 类要求的 EVM
  - 引脚可配置扩频
  - 可调节的 SW 节点上升时间
  - 高于和低于 AM 频带运行:引脚可配置为固定 400kHz 和 2.2MHz,或可在 200kHz 至 2.2MHz 之间调节
  - 低 EMI 对称引脚排列
  - 对于恒定频率或脉冲频率调制 (PFM), 轻负载模 式可对引脚进行配置
- 高效解决方案
  - 8A 负载可实现 95% 的效率
  - 在自动模式下空载时具有 5µA 的输入电流
  - <1µA 关断电流(典型值)
- 高功率密度
  - 内置补偿、软启动、电流限制、热关断和 UVLO
  - 4.5mm × 3.5mm 可湿性侧面 QFN 封装

### 2 应用

- 工业运输
- 航电设备
- 工业 PC
- PLC、DCS 和 PAC
- 半导体测试设备



### 3 说明

LM6x4xx 降压稳压器系列是稳压器,可提供固定或可 调节输出电压(可设置范围为 1V 至预期输入电压 的 95%)。这些稳压器可在宽输入电压范围(3V 至 36V)内工作,可承受高达 42V 的瞬态电压。

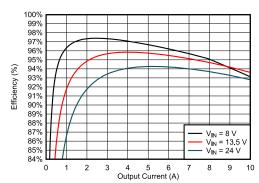
该系列专为低 EMI 而设计。该器件具有可选择引脚 的扩频和可调节的 SW 节点上升时间。双随机扩频 (DRSS) 跳频设置为 ±5.5%(典型值),通过三角和假 随机调制的组合大幅降低峰值发射。DRSS 还包括先 进技术,可降低由扩频调制引起的输出电压纹波。

开漏 RESET 输出具有滤波和延迟释放功能,可提供正 确的系统状态指示。在自动模式中,器件自动在固定频 率脉宽调制 (FPWM) 和脉冲频率调制 (PFM) 运行模式 之间转换,实现仅 5µA(典型值)的空载电流消耗。 电气特性额定结温范围为 -40°C 至 +150°C。

### 器件信息

器件型号	封装 <sup>(1)</sup>	封装尺寸(标称值)
LM61495		
LM61480	VQFN (16)	4.50mm × 3.50mm
LM62460		

如需了解所有可用封装,请参阅数据表末尾的可订购产品附 (1)



EVM 效率 ( $\Theta_{JA}$  = 21.6°C/W):  $V_{OUT} = 5V$  ,  $F_{SW} = 0.4MHz$ 



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4 Revision History 注:以前版本的页码可能与当前版本的页码不同

DATE	REVISION	NOTES
February 2021	*	Initial Release



## **5 Device Comparison Table**

DEVICE	VARIANT	LIGHT LOAD	SPREAD SPECTRUM	OUTPUT VOLTAGE	TYPICAL FREQUENCY	CURRENT
LM61495 (10-A Rating)	LM61495RPHR	Pin Selectable	Pin Selectable	Adjustable	0.4 MHz	10 A
LM61480 (8-A Rating)	LM61480RPHR	Pin Selectable	Pin Selectable	Adjustable	0.4 MHz	8 A
LM62460 (6-A Rating)	LM62460RPHR	Pin Selectable	Pin Selectable	Adjustable	2.2 MHz	6 A

# **6 Pin Configuration and Functions**

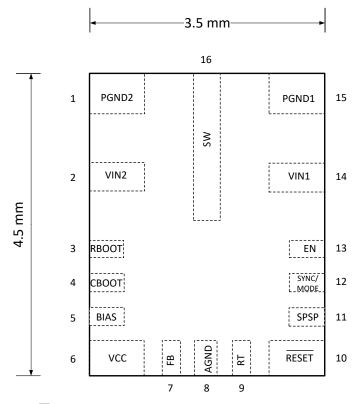


图 6-1. RPH Package 16-Pin VQFN (Top View)

表 6-1. Pin Functions

PIN		I/O	DESCRIPTION		
NAME	NO.	1/0	DESCRIPTION		
PGND2	1	G	Power ground to internal low-side MOSFET. Connect to system ground. Low impedance connection must be provided to PGND1. Connect a high-quality bypass capacitor or capacitors from this pin to VIN2.		
VIN2	IN2  2 Input supply to the regulator. Connect a high-quality bypass capacitor or capacitor or capacitor or pin to PGND2. Provide a low-impedance connection to VIN1.		Input supply to the regulator. Connect a high-quality bypass capacitor or capacitors from this pin to PGND2. Provide a low-impedance connection to VIN1.		
RBOOT	3	Р	Connect to CBOOT through a resistor. A resistance, typically between 0 $\Omega$ and 100 $\Omega$ , is used to adjust the slew rate of the SW node rise time. See $\Xi$ 8-10.		
СВООТ	4	Р	High-side driver upper supply rail. Connect a 100-nF capacitor between the SW pin and CBOOT. An internal diode charges the capacitor while SW node is low.		
BIAS	5	Р	Input to internal voltage regulator. Connect the pin to an output voltage point or an external bias supply from 3.3 V to 12 V. Connect an optional high-quality 0.1-µF capacitor from this pin to GND for the best performance. If output voltage is above 12 V and no external supply is used, tie the pin to ground.		



### 表 6-1. Pin Functions (continued)

PI	N	I/O	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
vcc	6	0	Internal regulator output. Used as supply to internal control circuits. Do not connect this pin to any external loads. Connect a high-quality 1-µF capacitor from this pin to AGND.
FB	7	I	Feedback input to regulator. Connect this pin to an output voltage sense point for fixed 3.3-V and 5-V output. Connect this pin to a feedback divider tap point for adjustable output options. Do not float or ground.
AGND	8	G	Analog ground for regulator and system. All electrical parameters are measured with respect to this pin. Connect this pin to PGND1 and PGND2 on PCB.
RT	9	I/O	Connect this pin to ground through a resistor with a value between 7 k $\Omega$ and 80 k $\Omega$ to set switching frequency between 200 kHz and 2200 kHz. Connect to VCC for 400 kHz. Connect to GND for 2.2 MHz. Do not float.
RESET	10	0	Open-drain RESET output. Connect to suitable voltage supply through a current limiting resistor. High = power OK, low = fault. RESET goes low when EN = low.
SPSP	11	I	Connect to VCC or through a resistor to ground to enable spread spectrum. Connect to GND to disable spread spectrum. If using spread spectrum, a VCC connection turns off the spread spectrum tone correction while a resistor to ground adjusts the tone correction to lower the output voltage ripple. Do not float this pin. See #8.3.10.
SYNC/MODE	12	I	This pin controls the mode of operation of the LM62460, LM61480, and LM61495. Modes include auto mode (automatic PFM/PWM operation), forced pulse width modulation (FPWM), and synchronized to an external clock. The clock triggers on the rising edge of an applied external clock. Pull low to enable PFM operation, pull high to enable FPWM, or connect to a clock to synchronize to an external frequency in FPWM mode. Do not float this pin.
EN	13	I	Precision enable input to regulator. High = on, low = off. Can be connected to VIN. Precision enable allows the pin to be used as an adjustable UVLO. Do not float. See $\#$ 8.3.2.
VIN1	14	Р	Input supply to the regulator. Connect a high-quality bypass capacitor or capacitors from this pin to PGND1. Low impedance connection must be provided to VIN2.
PGND1	15	G	Power ground to internal low-side MOSFET. Connect to system ground. Low impedance connection must be provided to PGND2. Connect a high-quality bypass capacitor or capacitors from this pin to VIN1.
SW	16	Р	Switch node of the regulator. Connect to the output inductor.

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### 7 Specifications

### 7.1 Absolute Maximum Ratings

Over the recommended operating junction temperature range<sup>(1)</sup>

	PARAMETER	MIN	MAX	UNIT
	Transient VIN to AGND, PGND <sup>(2)</sup>	-0.3	42	V
	Continuous VIN to AGND, PGND <sup>(2)</sup>	-0.3	36	V
	SW to AGND, PGND <sup>(3)</sup>	-0.3	V <sub>IN</sub> + 0.3	V
	RBOOT, CBOOT to SW	-0.3	42 36	V
Voltages	Transient EN or SYNC/EN to AGND, PGND <sup>(2)</sup>	-0.3	42	V
voltages	Continuous EN or SYNC/EN to AGND, PGND <sup>(2)</sup>	-0.3	36	V
	BIAS to AGND, PGND	-0.3	16	V
	FB to AGND, PGND: Fixed Versions	-0.3	16	V
	FB to AGND, PGND: Adjustable Versions	-0.3	5.5	V
Current	RESET to AGND, PGND	-3.5	20	V
	RESET sink current <sup>(5)</sup>	0	10	mA
	Transient SYNC/MODE to AGND, PGND <sup>(2)</sup>	-0.3	42	V
Voltages  Current  Voltages  T <sub>stg</sub>	Continuous SYNC/MODE to AGND, PGND <sup>(2)</sup>	-0.3	36	V
	RT to AGND, PGND	-0.3	5.5	V
	VCC to AGND, PGND	-0.3	5.5	V
	PGND to AGND <sup>(4)</sup>	-1	2	V
T <sub>stg</sub>	Storage temperature	-65	150	°C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) A maximum of 42 V can be sustained at this pin for duration of ≤ 100 ms at a duty cycle of ≤0.01%. 36 V can be sustained for the life of this device.
- (3) A voltage of 2 V below GND and 2 V above VIN can appear on this pin for ≤ 200 ns with a duty cycle of ≤ 0.01%.
- (4) This specification applies to voltage durations of 100 ns or less. The maximum D.C. voltage should not exceed ± 0.3 V.
- (5) Do not exceed the voltage rating of the pin.

#### 7.2 ESD Ratings

			VALUE	UNIT
V	Human-body model (HBM), per ANSI/ESDA/ JEDEC JS-001 <sup>(1)</sup>		±2000	V
$V_{(ESD)}$	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±750	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### 7.3 Recommended Operating Conditions

Over the recommended operating junction temperature range of -40°C to 150°C (unless otherwise noted) (1)

	, , , , , , , , , , , , , , , , , , , ,	MIN	MAX	UNIT
Input voltage	Input Voltage Range <sup>(1)</sup>	3	36	V
Input voltage	Output Adjustment Range for adjustable output versions (2)	1	0.95 * VIN	V
Output current	I <sub>OUT</sub> , LM62460	0	6	Α
Output current	I <sub>OUT</sub> , LM61480	0	8	Α
Output current	I <sub>OUT</sub> , LM61495	0	10	Α
Temperature	Operating junction temperature, T <sub>J</sub>	-40	150	°C

(1) An extended input voltage range to 3.0 V is possible after start up; see input UVLO for start-up conditions.



(2) Under no conditions should the output voltage be allowed to fall below zero volts.

#### 7.4 Thermal Information

		LM6x4xx	
	THERMAL METRIC(1)	RPH (VQFN)	UNIT
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	51.3	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	19.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	12.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	1.1	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	12	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	-	°C/W

- (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.
- (2) The value of R<sub>OJA</sub> given in this table is only valid for comparison with other packages and can not be used for design purposes. These values were calculated in accordance with JESD 51-7, and simulated on a 4-layer JEDEC board. They do not represent the performance obtained in an actual application. For example, the EVM R<sub>OJA</sub> = 21.6 °C/W. For design information please see the Layout Information section.

#### 7.5 Electrical Characteristics

Limits apply over the recommended operating junction temperature range of  $-40^{\circ}$ C to  $+150^{\circ}$ C, unless otherwise noted. Minimum and Maximum limits are guaranteed through test, design or statistical correlation. Typical values represent the most likely parametric norm at  $T_J = 25^{\circ}$ C, and are provided for reference purposes only. Unless otherwise stated the following conditions apply:  $V_{IN} = 13.5$  V. VIN1 shorted to VIN2 =  $V_{IN}$ . VOUT is output set point.

11	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLTA	AGE (VIN PIN)	,				
.,	NA::	Needed to start up			3.7	V
V <sub>IN</sub>	Minimum operating input voltage	Once operating			3	V
V <sub>IN_OP_H</sub>	Minimum voltage hysteresis			1		V
IQ	Non-switching input current; measured at VIN pin (1)	V <sub>IN</sub> = 13.5 V, V <sub>FB</sub> = +5%, V <sub>BIAS</sub> = 5 V		0.662	10	μA
I <sub>SD</sub>	Shutdown quiescent current; measured at VIN pin	V <sub>EN</sub> = 0 V, V <sub>IN</sub> = 13.5V		0.662	7.5	μA
I <sub>B</sub>	Current into BIAS pin (not switching)	$V_{IN}$ = 13.5 V, $V_{FB}$ = +5%, $V_{BIAS}$ = 5 V, auto mode enabled		18.5	26	μA
ENABLE (EN P	PIN)					
V <sub>EN</sub>	Enable input-threshold voltage - rising	V <sub>EN</sub> rising	1.161	1.263	1.365	V
V <sub>EN_HYST</sub>	Enable threshold hysteresis		0.25		0.5	V
V <sub>EN_WAKE</sub>	Enable wake-up threshold		0.4			V
I <sub>EN</sub>	Enable pin input current	V <sub>IN</sub> = V <sub>EN</sub> = 13.5 V		0.3	50	nA
INTERNAL LD	O (VCC PIN)				'	
V	Internal VCC valtage	V <sub>IN</sub> = 13.5 V, V <sub>BIAS</sub> = 0 V		3.3		V
V <sub>CC</sub>	Internal VCC voltage	V <sub>IN</sub> = 13.5 V, V <sub>BIAS</sub> = 3.3 V, 20 mA		3.1		V
V <sub>CC_UVLO</sub>	V <sub>IN</sub> voltage at which internal VCC undervoltage lockout is released	I <sub>VCC</sub> = 0 A			3.7	V
V <sub>CC_UVLO_HYST</sub>	Internal VCC undervoltage lockout hysteresis	Hysteresis below V <sub>CC_UVLO</sub>		1.2		V
VOLTAGE REF	ERENCE (FB PIN)				'	
V <sub>FB_3.3V</sub>	Initial reference voltage accuracy for 3.3-V option	V <sub>IN</sub> = 5 V to 36 V, FPWM mode	3.25875		3.34125	V
V <sub>FB_5V</sub>	Initial reference voltage accuracy for 5-V option	V <sub>IN</sub> = 6 V to 36 V, FPWM mode	4.9375		5.0625	V

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Limits apply over the recommended operating junction temperature range of  $-40^{\circ}$ C to +150°C, unless otherwise noted. Minimum and Maximum limits are guaranteed through test, design or statistical correlation. Typical values represent the most likely parametric norm at  $T_J$  = 25°C, and are provided for reference purposes only. Unless otherwise stated the following conditions apply:  $V_{IN}$  = 13.5 V. VIN1 shorted to VIN2 =  $V_{IN}$ . VOUT is output set point.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{FB}$	Initial reference voltage accuracy for adjustable (1 V FB) versions	V <sub>IN</sub> = 3.0 V to 36 V, FPWM mode	0.99	1	1.01	V
D	Resistance from FB to AGND	5-V fixed option		1.8		ΜΩ
$R_{FB}$	Resistance nom FB to AGND	3.3-V fixed option		2.2		IVILZ
I <sub>FB</sub>	Input current from FB to AGND	Adjustable versions only, V <sub>FB</sub> = 1 V			50	nA
CURRENT LIM	ITS					
I <sub>SC_6</sub>	Short circuit high-side current Limit		9	10.35	11.4	Α
I <sub>LS-LIMIT_6</sub>	Low-side current limit		6	6.9	7.7	Α
I <sub>PEAK-MIN_6</sub>	Minimum peak inductor current	6-A variant, duty cycle approaches 0%	0.9	1.2	1.5	Α
I <sub>L-NEG_6</sub>	Negative current limit		-3.6	-3	-2.4	Α
I <sub>SC_8</sub>	Short circuit high-side current limit		12	13.8	15.2	Α
I <sub>LS-LIMIT_8</sub>	Low-side current limit		8	9.2	10.2	Α
I <sub>PEAK-MIN 8</sub>	Minimum peak inductor current	8-A variant, duty cycle approaches 0%	1.2	1.6	2	Α
I <sub>L-NEG_8</sub>	Negative current limit		-4.8	-4	-3.2	Α
I <sub>SC_10</sub>	Short circuit high-side current Limit		14	17.3	20	Α
I <sub>LS-LIMIT 10</sub>	Low-side current limit		9.8	11.5	12.9	Α
I <sub>PEAK-MIN_10</sub>	Minimum peak inductor current	10-A variant, duty cycle approaches 0%		2		Α
I <sub>L-NEG_10</sub>	Negative current limit		-6.6	-5.3	-4	Α
I <sub>L-ZC</sub>	Zero-cross current limit. Positive current direction is out of SW pin.	Auto mode, static measurement	10		200	mA
V <sub>HICCUP</sub>	Hiccup threshold on FB pin		0.36	0.4	0.44	V
POWER GOOD	) (/RESET PIN)					
V <sub>RESET-OV</sub>	RESET upper threshold - rising	% of FB voltage	110	112	114	%
V RESET-UV	RESET lower threshold - falling	% of FB voltage	92	94	96.5	%
V RESET_GUARD	RESET UV threshold as percentage of steady state output voltage with output voltage and UV threshold, falling, read at the same T <sub>J</sub> , and V <sub>IN</sub> .	Falling			97	%
V RESET-HYS- FALLING	RESET fallling threshold hysteresis	% of FB voltage	0.5	1.3	2.5	%
V RESET-HYS- RISING	RESET rising threshold hysteresis	% of FB voltage	0.5	1.3	2.5	%
V RESET_VALID	Minimum input voltage for proper RESET function	Measured when $V_{RESET}$ < 0.4 V with 10- $k\Omega$ pullup to external 5 V			1.2	V
		46.0-μA pullup to $\overline{\text{RESET}}$ pin, $V_{\text{IN}}$ = 1.0 $V$ , $V_{\text{EN}}$ = 0 $V$			0.4	
VOL	RESET low-level function output voltage	1-mA pullup to RESET pin, V <sub>IN</sub> = 13.5 V, V <sub>EN</sub> = 0 V			0.4	٧
		2-mA pullup to RESET pin, V <sub>IN</sub> = 13.5 V, V <sub>EN</sub> = 3.3 V			0.4	
R <sub>RESET</sub>	RESET ON resistance	V <sub>EN</sub> = 5 V, 1-mA pullup current		44	125	Ω
R <sub>RESET</sub>	RESET ON resistance	V <sub>EN</sub> = 0 V, 1-mA pullup current		18	40	Ω
OSCILLATOR (	(SYNC/MODE PIN)		,	,	1	
V <sub>SYNCDL</sub>	SYNC/MODE input voltage low		0.4			V
V <sub>SYNCDH</sub>	SYNC/MODE input voltage high				1.7	V
V <sub>SYNCD_HYST</sub>	SYNC/MODE input voltage hysteresis		0.185		1	V



Limits apply over the recommended operating junction temperature range of  $-40^{\circ}$ C to +150°C, unless otherwise noted. Minimum and Maximum limits are guaranteed through test, design or statistical correlation. Typical values represent the most likely parametric norm at  $T_J = 25^{\circ}$ C, and are provided for reference purposes only. Unless otherwise stated the following conditions apply:  $V_{IN} = 13.5$  V. VIN1 shorted to VIN2 =  $V_{IN}$ . VOUT is output set point.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
R <sub>SYNC</sub>	Internal pulldown resistor to ensure SYNC/MODE doesn't float			100		kΩ
OSCILLATOR	(SPSP PIN)					
HIGH SIDE DR	RIVE (CBOOT PIN)					
V <sub>CBOOT_UVLO</sub>	Voltage on CBOOT pin compared to SW which turns off high-side switch			1.9		V
MOSFETS						
R <sub>DS-ON-HS</sub>	High-side MOSFET on-resistance	Load = 1 A, C <sub>BOOT-SW</sub> = 3.2 V		21	39	mΩ
R <sub>DS-ON-LS</sub>	Low-side MOSFET on-resistance	Load = 1 A, C <sub>BOOT-SW</sub> = 3.2 V		13	25	mΩ

<sup>(1)</sup> This is the current used by the device open loop. It does not represent the total input current of the system when in regulation.

### 7.6 Timing Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT				
PWM LIMITS (	PWM LIMITS (SW PIN)									
t <sub>ON-MIN</sub>	Minimum HS switch on time	V <sub>IN</sub> =18 V, V <sub>SYNC/MODE</sub> = 5 V, I <sub>OUT</sub> = 2 A		62	81	ns				
t <sub>OFF-MIN</sub>	Minimum HS switch off time	V <sub>IN</sub> = 5 V		70	103	ns				
t <sub>ON-MAX</sub>	Maximum switch on time	HS timeout in dropout	6.9	8.9	11	μs				
START UP										
t <sub>EN</sub>	Turnon delay	$V_{IN}$ = 13.5 V, Cvcc = 1 $\mu$ F, time from EN high to first SW pulse if output starts at 0 V		0.82	1.2	ms				
t <sub>SS</sub>	Time from first SW pulse to Vref at 90%, of set point		1.7	2.2	2.7	ms				
t <sub>W</sub>	Short circuit wait time (≈hiccup" time)			40		ms				
POWER GOOD	(/RESET PIN) and OVERVOLTAGE PRO	OTECTION								
t <sub>RESET_FILTER</sub>	RESET edge deglitch delay		10	26	45	μs				
t <sub>RESET_ACT</sub>	RESET active time	Time FB must be valid before $\overline{\text{RESET}}$ is released.	1.2	2.1	3.75	ms				
OSCILLATOR	(SYNC/MODE PIN)									
t <sub>PULSE_H</sub>	High duration needed to be recognized on SYNC/MODE pin		100			ns				
t <sub>PULSE_L</sub>	Low duration needed to be recognized on SYNC/MODE pin		100			ns				
t <sub>MSYNC</sub>	Time at one level needed to indicate FPWM or auto mode		7		20	μs				
t <sub>LOCK</sub>	Time needed for clock to lock to a valid synchronization signal	RT = 39.2 kΩ		4.3		ms				

#### 7.7 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OSCILLATOR (	RT and SYNC PINS)					
fosc	Internal oscillator frequency	RT = GND	1.9	2.2	2.42	MHz
fosc	Internal oscillator frequency	RT = VCC	350	400	440	kHz

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over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f <sub>FIXED_2.2MHz</sub>	Oscillator frequency measured using maximum value of RT resistor to select 2.2 MHz	RT = 6.81 kΩ	1.95	2.2	2.42	MHz
f <sub>FIXED_0.4MHz</sub>	Oscillator frequency measured using minimum value of RT resistor to select 0.4 MHz	RT = 40.2 kΩ	352	400	448	kHz
f <sub>ADJ</sub>	Center trim oscillator frequency	RT = 22.6 kΩ	630	700	770	kHz
f <sub>SYNC</sub>	Synchronization frequency range		200		2200	kHz
SPREAD SPE	CTRUM					
ΔFc+	Frequency increase of internal oscillator from spread spectrum		2	4	6.5	%
ΔFc-	Frequency decrease of internal oscillator from spread spectrum		-7	-5	-2	%
SWITCH NOD	E				'	
D	Maximum awitah dutu ayala	While in frequency fold-back	98			%
D <sub>MAX</sub>	Maximum switch duty cycle	fsw =1.85 MHz		87		70

### 7.8 System Characteristics

The following specifications apply only to the typical application circuit, with nominal component values. Specifications in the typical (TYP) column apply to  $T_J = 25^{\circ}$ C only. Specifications in the minimum (MIN) and maximum (MAX) columns apply to the case of typical components over the temperature range of  $T_J = -40^{\circ}$ C to 150°C. These specifications are not ensured by production testing.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLT	AGE (VIN PIN)					
V <sub>VIN_MIN1</sub>	Input voltage for full functionality at reduced load, after start-up.		3			V
V <sub>VIN_MIN2</sub>	Input voltage for full functionality at 100% of maximum rated load, after start-up.	V <sub>OUT</sub> set to 3.3 V	3.95			V
	Input current to V <sub>IN</sub> node of DC/DC for	$V_{IN}$ = 13.5 V, $V_{OUT}$ = 3.3 V fixed, $I_{OUT}$ = 0 A, Auto mode		5		
I <sub>Q_VIN</sub>	fixed V <sub>OUT</sub> versions	$V_{IN}$ = 13.5 V, $V_{OUT}$ = 5 V fixed, $I_{OUT}$ = 0 A, Auto mode		8		μA
VOLTAGE REF	ERENCE (FB PIN)					
V <sub>OUT_5V_ACC</sub>	$V_{OUT}$ = 5 V, $V_{IN}$ = 6 V to 36 V, $I_{OUT}$ = 1 A to full load <sup>(1)</sup>	V <sub>IN</sub> = 6 V to 36 V , PWM Operation	-1.5		1.5	%
	$V_{OUT}$ = 5 V, $V_{IN}$ = 6 V to 36 V, $I_{OUT}$ = 0 A to full load $^{(1)}$	V <sub>IN</sub> = 6 V to 36 V, PFM and PWM operation	-1.5		2.5	
V <sub>OUT_3r3V_ACC</sub>	$V_{\rm OUT}$ = 3.3 V, $V_{\rm IN}$ = 3.8 V to 36 V, $I_{\rm OUT}$ = 1 A to full load $^{(1)}$	V <sub>IN</sub> = 3.8 V to 36 V , PWM Operation	-1.5		1.5	%
	$V_{\rm OUT}$ = 3.3 V, $V_{\rm IN}$ = 3.8 V to 36 V, $I_{\rm OUT}$ = 0 A to full load $^{(1)}$	V <sub>IN</sub> = 3.8 V to 36 V, PFM and PWM operation	-1.5		2.5	
THERMAL SH	UTDOWN					
T <sub>SD_R</sub>	Thermal shutdown tripping threshold		158	168	180	°C
T <sub>SD_F</sub>	Thermal shutdown recovery threshold		150	159		°C
OTHER PARAL	MATERS					
V <sub>DROP1</sub>	Input to output voltage differential to maintain regulation accuracy, without inductor DCR drop		0.45			V
V <sub>DROP2</sub>	Input to output voltage differential to maintain f <sub>SW</sub> ≥ 1.85 MHz, without inductor DCR drop		1.2			V



The following specifications apply only to the typical application circuit, with nominal component values. Specifications in the typical (TYP) column apply to  $T_J = 25^{\circ}$ C only. Specifications in the minimum (MIN) and maximum (MAX) columns apply to the case of typical components over the temperature range of  $T_J = -40^{\circ}$ C to 150°C. These specifications are not ensured by production testing.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Typical 2.2MHz Efficiency	$V_{IN}$ =13.5 V, $V_{OUT}$ = 5.0 V, $I_{OUT}$ = 5 A, $R_{RBOOT}$ = 0 $\Omega$		92.6		
η	Typical 400 kHz Efficiency	$V_{IN}$ = 13.5 V, Vout = 5.0 V, $I_{OUT}$ = 8 A, $R_{RBOOT}$ = 0 $\Omega$		95.1		%
	Typical 250 kHz Efficiency	$V_{IN}$ = 13.5 V, Vout = 5.0 V, $I_{OUT}$ = 10 A, $R_{RBOOT}$ = 0 $\Omega$		93.7		



### **8 Detailed Description**

#### 8.1 Overview

The LM6x4xx is a wide input and output voltage range, low quiescent current, high-performance regulator that operates over a wide range of frequencies and conversion ratios. If the minimum on-time or minimum off-time does not support the desired conversion ratio, the frequency is reduced. This action automatically allows regulation to be maintained during load dump and with very low dropout during cranking.

This device is designed to minimize end-product cost and size while operating in high-performance industrial environments. The LM6x4xx can be set to operate at fixed 400 kHz, fixed 2.2 MHz, or is adjustable from 200 kHz to 2.2 MHz using the RT pin. Internal compensation and an accurate current limit scheme minimizes BOM cost and component count. In addition, the RESET output feature with built-in delayed release and low current light-load mode let you eliminate a backup LDO and reset chip in many applications.

The LM6x4xx has been designed for low EMI. The device includes the following:

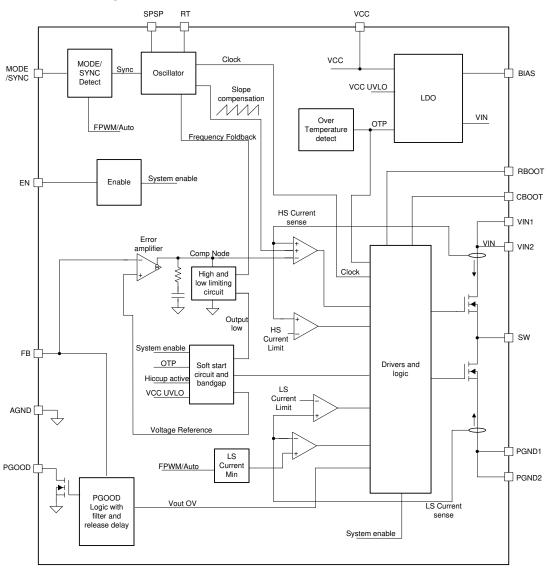
- · Adjustable switch node slew rate
- · Pin-configurable spread spectrum
- · Low input inductance package
- Operation over a frequency range above and below AM radio band operation

Together, these features can eliminate shielding and other expensive EMI mitigation measures.

To use the device in reliability-conscious environments, the LM6x4xx has a package with enlarged corner terminals for improved BLR and wettable flanks, allowing optical inspection.



### 8.2 Functional Block Diagram





### 8.3 Feature Description

#### 8.3.1 Output Voltage Selection

A voltage divider between output voltage and the FB pin is used to adjust output voltage. See 8-1.

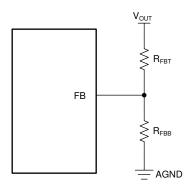


图 8-1. Setting Output Voltage of Adjustable Versions

$$R_{FBB} = \frac{R_{FBT}}{V_{OUT} - 1}$$

(1)

In addition, a feedforward capacitor C<sub>FF</sub> can be used to optimize the transient response.

#### 8.3.2 Enable EN Pin and Use as V<sub>IN</sub> UVLO

Apply a voltage less than 0.4 V to the EN pin to put the device into shutdown mode. In shutdown mode, the quiescent current drops to 0.66  $\mu$ A (typical). Above this voltage but below the LM6x4xx lower EN threshold, VCC is active but the SW node remains inactive. Once EN is above  $V_{EN}$ , the chip operates normally as long as input voltage is above the minimum operating voltage.

The EN terminal cannot be left floating. The simplest way to enable the operation is to connect the EN pin to VIN. This action allows the self-start-up of the device when VIN drives the internal VCC above its UVLO level. However, many applications benefit from employing an enable divider string, which establishes a precision input undervoltage lockout (UVLO). The precision UVLO can be used for the following:

- Sequencing
- Preventing the device from retriggering when used with long input cables
- Reducing the occurrence of deep discharge of a battery power source

Note that EN thresholds are accurate. The rising enable threshold has 8.1% tolerance. Hysteresis is enough to prevent retriggering upon shutdown of the load (approximately 25%). The external logic output of another IC can also be used to drive the EN terminal, allowing system power sequencing.



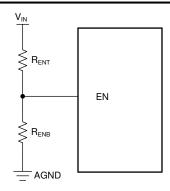


图 8-2. VIN UVLO Using the EN Pin

Resistor values can be calculated using 方程式 2:

$$R_{\text{ENB}} = R_{\text{ENT}} \cdot \frac{V_{\text{EN}}}{V_{\text{ON}} - V_{\text{EN}}}$$

(2)

Here, V<sub>ON</sub> is the desired typical start-up voltage for the circuit being designed.

### 8.3.3 SYNC/MODE Uses for Synchronization

The LM6x4xx SYNC/MODE pin can be used to synchronize the internal oscillator to an external clock. The internal oscillator can be synchronized by coupling a positive edge into the SYNC/MODE pin. The coupled edge voltage at the SYNC/MODE pin must exceed the SYNC amplitude threshold of  $V_{SYNCDH}$  to trip the internal synchronization pulse detector. The minimum SYNC rising pulse and falling pulse durations must be longer than  $t_{PULSE}$ . The LM6x4xx switching action can be synchronized to an external clock from 200 kHz to 2.2 MHz.

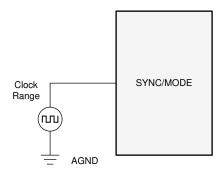
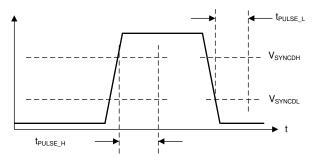


图 8-3. Typical Implementation Allowing Synchronization Using the SYNC/MODE Pin



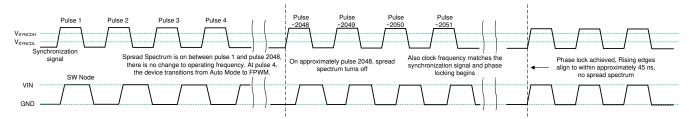
This image shows the conditions needed for detection of a synchronization signal.

图 8-4. Typical SYNC/MODE Waveform



#### 8.3.4 Clock Locking

Once a valid synchronization signal is detected, a clock locking procedure is initiated. After approximately 2048 pulses, the clock frequency abruptly changes to the frequency of the synchronization signal. While the frequency adjusts suddenly, phase is maintained so the clock cycle lying between operation at the default and synchronization frequencies is of intermediate length. There are no very long or very short pulses. Once frequency is adjusted, phase is adjusted over a few tens of cycles so that rising synchronization edges correspond to rising the SW node pulses. See Synchronization Process.



At pulse 4, the synchronization signal is detected. After approximately pulse 2048, it is ready to synchronize and the frequency is adjusted using a glitch-free technique. Later, phase is locked.

### 图 8-5. Synchronization Process

### 8.3.5 Adjustable Switching Frequency

The RT pin is configurable. This pin can be tied to VCC for 400-kHz operation, grounded for 2.2-MHz operation, or a resistor to AGND can be used to set an adjustable operating frequency. See ₹8-6 for resistor values. Note that if a resistor value falls outside of the recommended range, it can cause the LM6x4xx to revert to 400 kHz or 2.2 MHz. Do not apply a pulsed signal to this pin to force synchronization. If synchronization is needed, see the SYNC/MODE pin in ₹8.3.3.

$$R_T (k\Omega) = (16.4 / f_{SW (MHz)}) - 0.633$$
 (3)

For example, for  $f_{SW}$  = 400 kHz,  $R_T$  = (16.4 / 0.4) - 0.633 = 40.37, so a 40.2-k resistor is selected as the closest choice.

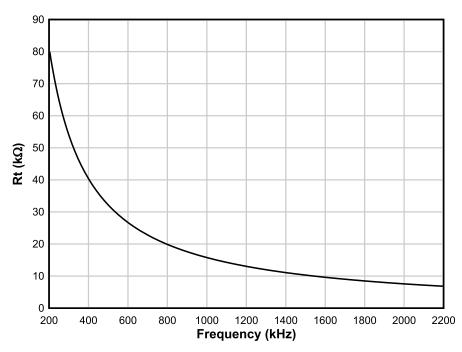


图 8-6. Setting Clock Frequency



### 8.3.6 RESET Output Operation

While the RESET function of the LM6x4xx resembles a standard power-good function, the functionality is designed to replace a discrete reset IC, reducing BOM cost. There are three major differences between the reset function and the normal power-good function seen in most regulators:

- A delay has been added for release of reset. See 表 8-1.
- RESET output signals a fault (pulls its output to ground) while the part is disabled.
- RESET continues to operate with input voltage as low as 1.2 V. Below this input voltage, RESET output can be high impedance.

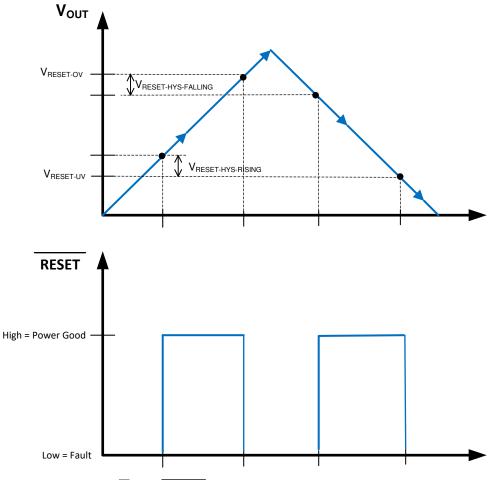


图 8-7. RESET Static Voltage Thresholds



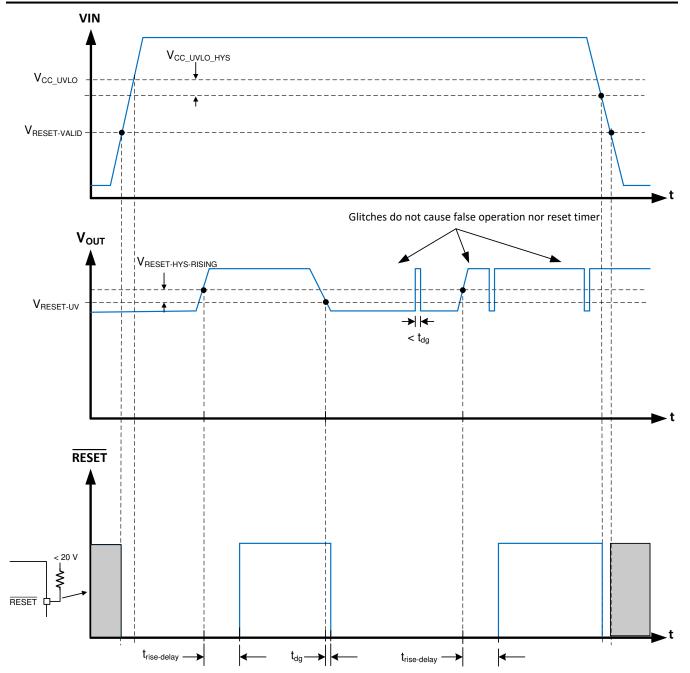


图 8-8. RESET Timing Diagram (Excludes OV Events)



FAULT CONDITION INITIATED	FAULT CONDITION ENDS (AFTER WHICH t <sub>RESET_ACT</sub> MUST PASS BEFORE RESET OUTPUT IS RELEASED)
FB below V <sub>RESET_UV</sub> for longer than t <sub>RESET_FILTER</sub>	FB above V <sub>RESET_UV</sub> + V <sub>RESET_HYST</sub> for longer than t <sub>RESET_FILTER</sub>
FB above V <sub>RESET_OV</sub> for longer than t <sub>RESET_FILTER</sub>	FB below V <sub>RESET_OV</sub> - V <sub>RESET_HYST</sub> for longer than t <sub>RESET_FILTER</sub>
Junction temperature exceeds T <sub>SD_R</sub>	Junction temperature falls below T <sub>SD_F</sub> <sup>(1)</sup>
EN low	t <sub>EN</sub> passes after EN becomes high <sup>(1)</sup>
VIN falls low enough so that VCC falls below $V_{CC\_UVLO}$ - $V_{CC\_UVLO\_HYST}$ . This value is called $V_{IN\_OPERATE}$ .	Voltage on VIN is high enough so that VCC pin exceed V <sub>CC_UVLO</sub> (1)

(1) As an additional operational check, RESET remains low during soft start. It is defined as until the lesser of either full output voltage reached or t<sub>SS2</sub> has passed since initiation. This is true even if all other conditions in this table are met and t<sub>RESET\_ACT</sub> has passed. Lockout during soft start does not require t<sub>RESET\_ACT</sub> to pass before RESET is released.

The threshold voltage for the RESET function is specified to take advantage of the availability of the LM6x4xx internal feedback threshold to the RESET circuit. This allows a maximum threshold of 96.5% of selected output voltage to be specified at the same time as 96% of actual operating point. The net result is a more accurate reset function while expanding the system allowance for transient response. See the output voltage error stack-up comparison in 88-9.

In addition to signaling a fault upon overvoltage detection (FB above V<sub>RESET\_OV</sub>), the switch node is shut down and a small, approximately 1-mA pulldown is applied to the SW node.

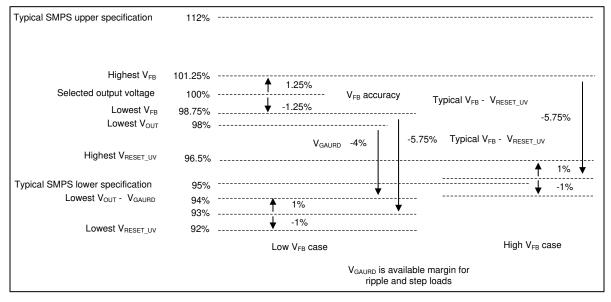


图 8-9. Reset Threshold Voltage Stack-up

#### 8.3.7 Internal LDO, VCC UVLO, and BIAS Input

The LM6x4xx uses VCC as its internal power supply. VCC is, in turn, powered from VIN or BIAS. Once the LM6x4xx is active, power comes from VIN if BIAS is less than approximately 3.1 V. Power comes from BIAS if BIAS is more than 3.1 V. VCC is typically 3 V to 3.3 V under most conditions, but can be lower if VIN is very low. To prevent unsafe operation, VCC has a UVLO that prevents switching if the internal voltage is too low. See  $V_{CC\_UVLO\_HYST}$  in #7.5. During start-up, VCC momentarily exceeds its normal operating voltage until  $V_{CC\_UVLO}$  is exceeded, then drops to its normal operating voltage. These UVLO values, when combined with the dropout of the LDO when only powering the LM6x4xx, are used to derive minimum  $V_{IN\_OPERATE}$  and  $V_{IN\_OP\_H}$ .

### 8.3.8 Bootstrap Voltage and V<sub>CBOOT-UVLO</sub> (CBOOT Pin)

The driver of the power switch (HS switch) requires bias higher than VIN when the HS switch is ON. The capacitor connected between CBOOT and SW works as a charge pump to boost voltage on the CBOOT

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terminal to (SW + VCC). The boot diode is integrated on the LM6x4xx die to minimize the physical solution size. TI recommends a 100-nF capacitor rated for 10 V with X7R or better dielectric for the CBOOT capacitor. The boot (CBOOT) rail has a UVLO to protect the chip from operation with too little bias. This UVLO has a threshold of  $V_{BOOT\_UVLO}$  and is typically 2.1 V. If the CBOOT capacitor voltage drops below  $V_{BOOT\_UVLO}$ , then the device initiates a charging sequence using the low-side FET before attempting to turn on the high-side device.

### 8.3.9 Adjustable SW Node Slew Rate

To allow optimization of EMI with respect to efficiency, the LM6x4xx is designed to allow a resistor to select the strength of the high-side FET driver during turnon. See 8-10. The current drawn through the RBOOT pin (the dotted loop) is magnified and drawn through from CBOOT (the dashed line). This current is used to turn on the high-side power MOSEFT.

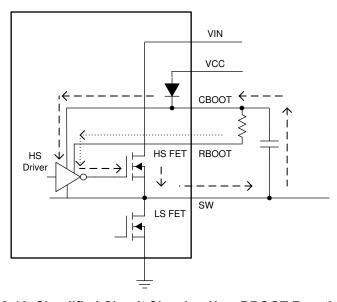


图 8-10. Simplified Circuit Showing How RBOOT Functions

Rise time is rapid with RBOOT short circuited to CBOOT. SW node harmonics do not roll off until above 150 MHz. If CBOOT and RBOOT are connected through 700  $\Omega$ , slew time due to high-side turnon is limited to no more than 13 ns. 10 ns is typical when converting 13.5 V to 5 V. This slow rise time allows energy in SW node harmonics to roll off near 50 MHz under most conditions. Rolling off harmonics eliminates the need for shielding and common mode chokes in many applications. Note that rise time increases with increasing input voltage. Noise due to stored charge is also greatly reduced with higher RBOOT resistance. Switching with a slower slew rate decreases efficiency. Take care to optimize the resistance to provide the best EMI while not generating too much heat. If RBOOT is left open, rise time is set to its maximum value; see the *Electrical Characteristics*.

#### 8.3.10 Spread Spectrum

Spread spectrum is configurable using the SPSP pin. Spread spectrum is eliminates peak emissions at specific frequencies by spreading these peaks across a wider range of frequencies than a part with fixed-frequency operation. The LM6x4xx implements a modulation pattern designed to reduce low frequency-conducted emissions from the first few harmonics of the switching frequency. The pattern can also help reduce the higher harmonics that are more difficult to filter, which can fall in the FM band. These harmonics often couple to the environment through electric fields around the switch node and inductor. The LM6x4xx uses a ±5% spread of frequencies which can spread energy smoothly across the FM and TV bands. The device implements Dual Random Spread Spectrum (DRSS). DRSS is a combination of a triangular frequency spreading pattern and pseudorandom frequency hopping. The combination allows the spread spectrum to be very effective at spreading the energy at the following:

- Fundamental switching harmonic with slow triangular pattern
- High frequency harmonics with additional psuedorandom jumps at the switching frequency



The advantage of DRSS is its equivalent harmonic attenuation in the upper frequencies with a smaller fundamental frequency deviation. This reduces the amount of input current and output voltage ripple that is introduced at the modulating frequency. Additionally, the LM6x4xx also allows you to further reduce the output voltage ripple caused by the spread spectrum modulating pattern. With the SPSP pin grounded, the spread spectrum is disabled. With the SPSP pin tied to VCC, the spread spectrum is on. With the SPSP pin tied through a resistor to ground, the spread spectrum is on. Also, a modulating tone correction is applied to the switcher to reduce the output voltage ripple caused by the frequency modulation. The resistor is usually around 20 k $\Omega$ , and can be more precisely calculated using  $\hbar$ 

$$R_{SPSP} (k\Omega) = \frac{14.17 \times \frac{V_{IN}}{V_{OUT}}}{\frac{V_{IN} - V_{OUT}}{I_{RATED} \times L \times f_{SW}} + 1.22}$$
(4)

The spread spectrum is only available while the clock of the LM6x4xx are free running at their natural frequency. Any of the following conditions overrides spread spectrum, turning it off:

- The clock is slowed due to operation at low input voltage. This is operation in dropout.
- The clock is slowed under light load in auto mode. This is normally not seen above 750-mA load. Note that if the device is operating in FPWM mode, spread spectrum is active, even if there is no load.
- The clock is slowed due to high input-to-output voltage ratio. This mode of operation is expected if on-time reaches minimum on-time. See the *Timing Characteristics*.
- The clock is synchronized with an external clock.

### 8.3.11 Soft Start and Recovery From Dropout

When designing with the LM6x4xx, slowed rise in output voltage due to recovery from dropout and soft start must be considered separate phenomena. Soft start is triggered by any of the following conditions:

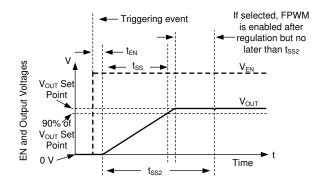
- EN is used to turn on the device.
- Recovery from a hiccup waiting period; see # 8.3.13.
- Recovery from shutdown due to overtemperature protection
- Power is applied to the VIN of the IC or the VCC UVLO is released.

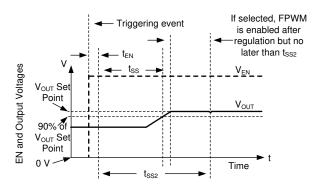
Once soft start is triggered, the IC takes the following actions:

- The reference used by the IC to regulate output voltage is slowly ramped from zero. The net result is that output voltage, if previously 0 V, takes t<sub>SS</sub> to reach 90% of its desired value.
- Operating mode is set to auto, activating diode emulation. This allows start-up without pulling output low if there is a voltage already present on the output.
- Hiccup is disabled for the duration of soft start; see #8.3.13.

All of these actions together provide start-up with limited inrush currents. They also allow the use of output capacitors and loading conditions that cause current to border on current limit during start-up without triggering hiccup. In addition, if output voltage is already present, output is not pulled down. See Soft-Start Operation.







The left curves show soft start from 0 V. The right curves show soft starting behavior from a pre-biased or non-zero voltage. In either case, the output voltage reaches within 10% of the desired setpoint  $t_{SS}$  time after soft start is initiated. During soft start, FPWM and hiccup are disabled. Both hiccup and FPWM are enabled once output reaches regulation or  $t_{SS2}$ , whichever happens first.

#### 图 8-11. Soft-Start Operation

Any time output voltage is more than a few percent low for any reason, output voltage ramps up slowly. This condition, called recovery from dropout, differs from soft start in three important ways:

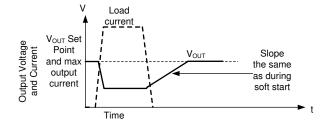
- Hiccup is allowed only if output voltage is less than 0.4 times its set point. Note that during dropout regulation itself, hiccup is inhibited. See *Hiccup*.
- FPWM mode is allowed during recovery from dropout. If output voltage were to suddenly be pulled up by an external supply, the LM6x4xx can pull down on the output. Note that all the protections that are present during normal operation are in place, protecting the device if output is shorted to a high voltage or ground.
- The reference voltage is set to approximately 1% above that needed to achieve the current output voltage. It is not started from zero.

Despite the name, recovery from dropout is active whenever output voltage is more than a few percent lower than the setpoint for long enough that:

- Duty factor is controlled by minimum on-time or
- When the part is operating in current limit.

This primarily occurs under the following conditions:

- Dropout: When there is insufficient input voltage for the desired output voltage to be generated. See # 8 3 13
- Overcurrent that is not severe enough to trigger hiccup or if the duration is too short to trigger hiccup. See #8.3.13.



Whether output voltage falls due to high load or low input voltage, once the condition that causes output to fall below its setpoint is removed, output climbs at the same speed as during start-up. Even though hiccup does not trigger due to dropout, it can, in principal, be triggered during recovery if output voltage is below 0.4 times output the setpoint for more than 128 clock cycles during recovery.

#### 图 8-12. Recovery From Dropout



#### 8.3.12 Overcurrent and Short Circuit Protection

The LM6x4xx is protected from overcurrent conditions by cycle-by-cycle current limiting on both the high-side and the low-side MOSFETs.

High-side MOSFET overcurrent protection is implemented by the nature of the peak current mode control. The HS switch current is sensed when the HS is turned on after a short blanking time. The HS switch current is compared to the minimum of a fixed current setpoint, or the output of the voltage regulation loop minus slope compensation, every switching cycle. Since the voltage loop has a maximum value and slope compensation increases with duty, the cycle HS current limit decreases with increased duty factor if duty factor is above 35%. See  $8 \cdot 13$ .

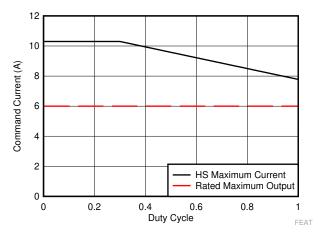


图 8-13. Maximum Current Allowed Through the HS FET - Function of Duty Factor for LM62460-Q1

When the LS switch is turned on, the current going through it is also sensed and monitored. Like the high-side device, the low-side device turnoff is commanded by the voltage control loop. For a low-side device, turnoff is prevented if current exceeds this value, even if the oscillator normally starts a new switching cycle. See #8.4.3.4. Also like the high-side device, there is a limit on how high the turnoff current is allowed to be. This is called the low-side current limit; see the *Electrical Characteristics* for values. If the LS current limit is exceeded, the LS MOSFET stays on and the HS switch is not turned on. The LS switch is turned off once the LS current falls below its limit. The HS switch is turned on again as long as at least one clock period has passed since the last time the HS device has turned on.

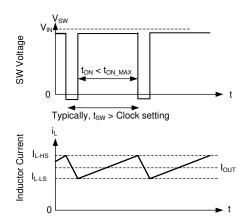


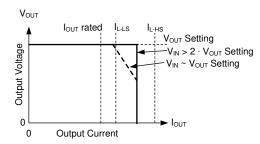
图 8-14. Current Limit Waveforms

The net effect of the operation of high-side and low-side current limit is that the IC operates in hysteretic control. Since the current waveform assumes values between  $I_{L-HS}$  and  $I_{L-LS}$ , output current is close to the average of



these two values unless duty factor is very high. Once operating in current limit, hysteretic control is used and current does not increase as output voltage approaches zero.

If duty factor is very high, current ripple must be very low to prevent instability; see # 9.2.2.3. Since current ripple is low, the part is able to deliver full current. The current delivered is very close to  $I_{L-LS}$ .



Under most conditions, current is limited to the average of  $I_{L-HS}$  and  $I_{L-LS}$ , approximately 1.4 times the rated current. If input voltage is low, current can be limited to approximately  $I_{L-LS}$ . Current does not exceed the average of  $I_{L-HS}$  and  $I_{L-LS}$  as output drops to 0.4 times the output voltage setting. Below 0.4 times the output voltage setting, the peak current does not exceed the average of  $I_{L-HS}$  and  $I_{L-LS}$  and the hiccup mode activates, preventing excessive heating.

### 图 8-15. Output Voltage versus Output Current

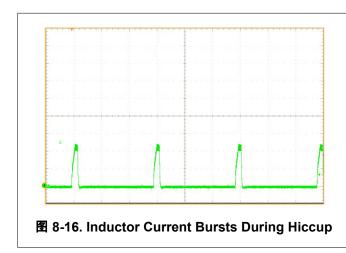
Once the overload is removed, the device recovers as though in soft start; see # 8.3.11. Note that hiccup can be triggered if output voltage drops below approximately 0.4 times the intended output voltage.

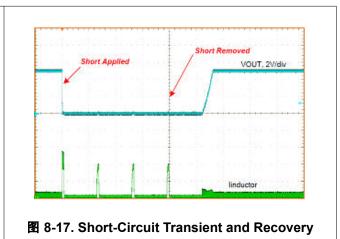
#### 8.3.13 Hiccup

The LM6x4xx employs hiccup overcurrent protection when the following conditions are met 128 consecutive switching cycles:

- A time greater than t<sub>SS2</sub> has passed since soft start has started; see #8.3.11.
- Output voltage is below approximately 0.4 times output setpoint.
- The part is not operating in dropout defined as having minimum off-time controlled by duty factor.

In hiccup mode, the device shuts itself down and attempts to soft start after  $t_W$ . Hiccup mode helps reduce the device power dissipation under severe overcurrent conditions and short circuits.





8.3.14 Thermal Shutdown

Thermal shutdown limits total power dissipation by turning off the internal switches when the IC junction temperature exceeds 165°C (typical). Thermal shutdown does not trigger below 158°C. After thermal shutdown



occurs, hysteresis prevents the device from switching until the junction temperature drops to approximately 155°C. When the junction temperature falls below 155°C (typical), the LM6x4xx attempts to soft start.

While the LM6x4xx is shut down due to high junction temperature, power continues to be provided to VCC. To prevent overheating from a short circuit applied to VCC, the LDO providing power to VCC has reduced current limit while the part is disabled due to high junction temperature. The LDO only provides a few milliamperes during thermal shutdown.

#### 8.4 Device Functional Modes

#### 8.4.1 Shutdown Mode

The EN pin provides electrical on and off control of the device. When the EN pin voltage is below 0.4 V, both the regulator and the internal LDO have no output voltage and the part is in shutdown mode. In shutdown mode, the quiescent current drops to typically  $2 \mu A$ .

### 8.4.2 Standby Mode

The internal LDO has a lower EN threshold than the output of the regulator. The internal LDO regulates the VCC voltage at 3.3 V, typically when:

- The EN pin voltage is above 1.1 V (maximum) and
- The EN pin voltage is below the precision enable threshold for the output voltage.

The precision enable circuitry is ON once VCC is above its UVLO. The internal power MOSFETs of the SW node remain off unless the voltage on the EN terminal goes above its precision enable threshold. The LM6x4xx also employs UVLO protection. If the VCC voltage is below its UVLO level, the output of the regulator is turned off.

The control scheme of the LM6x4xx allows the device to operate under a wide range of conditions with a low number of external components. Peak current mode control allows a wide range of input voltages and output capacitance values, while maintaining a constant switching frequency. Stable operation is maintained while output capacitance is changed during operation. This allows use in systems that require high performance during load transients and have load switches which remove loads as the system operating state changes. Short minimum on-times and off-times ensure constant frequency regulation over a wide range of conversion ratios. This architecture uses frequency foldback to achieve low dropout voltage, maintaining output regulation as input voltage falls close to output voltage. The foldback is smooth and continuous, and activated as off-time approaches its minimum. Under these conditions, the LM6x4xx operates much like a constant off-time converter, allowing the maximum duty cycle to reach at least 98%.

### 8.4.3 Active Mode

The LM6x4xx is in active mode when the following occurs:

- The EN pin is above V<sub>FN</sub>.
- V<sub>IN</sub> is above V<sub>EN</sub>.
- V<sub>IN</sub> is high enough to satisfy the V<sub>IN</sub> minimum operating input voltage.
- No other fault conditions are present.

See # 8.3 for protection features. The simplest way to enable the operation is to connect EN to VIN, allowing self-start-up when the applied input voltage exceeds the minimum  $V_{IN\_OPERATE}$ .

In active mode, depending on the load current, input voltage, and output voltage, the LM6x4xx is in one of six sub-modes:

- · Continuous conduction mode (CCM) with fixed switching frequency and peak current mode operation
- Discontinuous conduction mode (DCM) while in auto mode when the load current is lower than half of the inductor current ripple
- Minimum on-time operation while the on-time of the device needed for full-frequency operation at the requested low-duty cycle is not supported by T<sub>ON MIN</sub>
- Forced pulse width modulation (FPWM) similar to CCM with fixed-switching frequency, but extends the fixed frequency range of operation from full to no load
- · Dropout mode when switching frequency is reduced to minimize dropout



• Recovery from dropout similar to other modes of operation except the output voltage setpoint is gradually moved up until the programmed setpoint is reached.

#### 8.4.3.1 Peak Current Mode Operation

The following operating description of the LM6x4xx refers to #8.2 and the waveforms in &8-18. Both supply a regulated output voltage by turning on the internal high-side (HS) and low-side (LS) NMOS switches with varying duty cycle (D). During the HS switch on-time, the SW terminal voltage,  $V_{SW}$ , swings up to approximately  $V_{IN}$ , and the inductor current,  $i_L$ , increases with a linear slope. The HS switch is turned off by the control logic. During the HS switch off-time,  $t_{OFF}$ , the LS switch is turned on. Inductor current discharges through the LS switch, forcing  $V_{SW}$  to swing below ground by the voltage drop across the LS switch. The regulator loop adjusts the duty cycle to maintain a constant output voltage. D is defined by the on-time of the HS switch over the switching period:  $D = T_{ON}/T_{SW}$ .

In an ideal buck converter where losses are ignored, D is proportional to the output voltage and inversely proportional to the input voltage:  $D = V_{OUT} / V_{IN}$ .

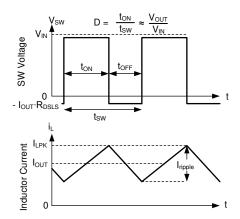


图 8-18. SW Voltage and Inductor Current Waveforms in Continuous Conduction Mode (CCM)

To get accurate DC load regulation, a voltage feedback loop is used. Peak and valley inductor currents are sensed for peak current mode control and current protection. The regulator operates with continuous conduction mode with constant switching frequency when load level is above one half of the minimum peak inductor current. The internally-compensated regulation network achieves fast and stable operation with small external components and low-ESR capacitors.

#### 8.4.3.2 Auto Mode Operation

The LM6x4xx can have two behaviors while lightly loaded. One behavior, called auto mode operation, allows a seamless transition between normal current mode operation while heavily loaded and in highly-efficient light-load operation. The other behavior, called FPWM mode, maintains full frequency even when unloaded. Which mode the LM6x4xx operates in depends on the SYNC/MODE pin. When SYNC/MODE is high, the part is in FPWM. When SYNC/MODE is low, the part is in PFM.

In auto mode, light-load operation is employed in the LM6x4xx at load lower than approximately 1/10th of the rated maximum output current. Light-load operation employs two techniques to improve efficiency:

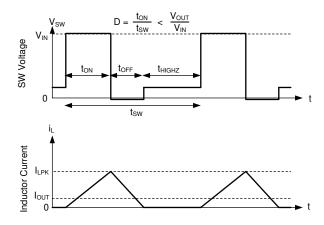
- · Diode emulation, which allows DCM operation
- Frequency reduction

Note that while these two features operate together to create excellent light load behavior, they operate independently of each other.



#### 8.4.3.2.1 Diode Emulation

Diode emulation prevents reverse current though the inductor, which requires a lower frequency needed to regulate given a fixed peak inductor current. Diode emulation also limits ripple current as frequency is reduced. With a fixed peak current, as output current is reduced to zero, frequency must be reduced to near zero to maintain regulation.



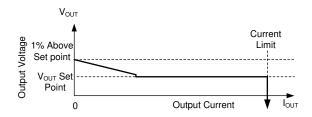
In auto mode, the low-side device is turned off once inductor current is near zero. As a result, once output current is less than half of inductor ripple in CCM, the part operates in DCM. This is equivalent to saying that diode emulation is active.

#### 图 8-19. PFM Operation

The LM6x4xx has a minimum peak inductor current setting in auto mode. That being said, when current is reduced to a low value with fixed input voltage, on-time is constant. Regulation is then achieved by adjusting frequency. This mode of operation is called PFM mode regulation.

### 8.4.3.2.2 Frequency Reduction

The LM6x4xx reduces frequency whenever the output voltage is above the setpoint. This function is enabled whenever Comp, an internal signal, is low and an offset between the regulation setpoint of FB and the voltage applied to FB. The net effect is that there is larger output impedance while lightly loaded in auto mode than in normal operation. Output voltage must be approximately 1% high when the part is completely unloaded, as shown in Steady State Output Voltage versus Output Current in Auto Mode.



In auto mode, once output current drops below approximately 1/10th of the rated current of the part, output resistance increases so that output voltage is 1% high while the buck is completely unloaded.

#### 图 8-20. Steady State Output Voltage versus Output Current in Auto Mode

In PFM operation, a small DC positive offset is required on the output voltage to activate the PFM detector. The lower the frequency in PFM, the more DC offset is needed on VOUT. If the DC offset on VOUT is not acceptable, a dummy load at VOUT or FPWM mode can be used to reduce or eliminate this offset.

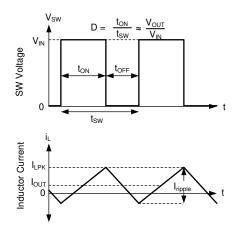
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### 8.4.3.3 FPWM Mode Operation

Like auto mode operation, FPWM mode operation during light-load operation is selected using the SYNC/MODE pin.

In FPWM Mode, frequency is maintained while lightly loaded. To maintain frequency, a limited reverse current is allowed to flow through the inductor. Reverse current is limited by reverse current limit circuitry. See the *Electrical Characteristics* for reverse current limit values.



FPWM mode Continuous Conduction (CCM) is possible even if I<sub>OUT</sub> is less than half of Iripple.

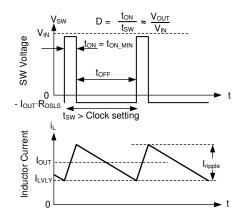
### 图 8-21. FPWM Mode Operation

In FPWM mode, frequency reduction is still available if output voltage is high enough to command minimum on-time, even while lightly loaded. This allows good behavior during faults which involves the output being pulled up.

### 8.4.3.4 Minimum On-time (High Input Voltage) Operation

The LM6x4xx continues to regulate output voltage. This is true even if the input-to-output voltage ratio requires an on-time less than the minimum on-time of the chip with a given clock setting. This is accomplished using valley current control. At all times, the compensation circuit dictates both a maximum peak inductor current and a maximum valley inductor current. If, for any reason, valley current is exceeded, the clock cycle is extended until valley current falls below that determined by the compensation circuit. If it is not operating in current limit, the maximum valley current is set above the peak inductor current. This prevents valley control from being used unless there is a failure to regulate using peak current only. If the input voltage-to-output voltage ratio is too high, even though current exceeds the peak value dictated by compensation, the high-side device cannot be turned off quickly enough to regulate output voltage. See ton minimum to the Electrical Characteristics. As a result, the compensation circuit reduces both peak and valley current. Once a low enough current is selected by the compensation circuit, valley current matches that being commanded by the compensation circuit. Under these conditions, the low-side device is kept on and the next clock cycle is prevented from starting until inductor current drops below the desired valley current. Since on-time is fixed at its minimum value, this type of operation resembles that of a device using a COT control scheme. See Valley Current Mode Operation.



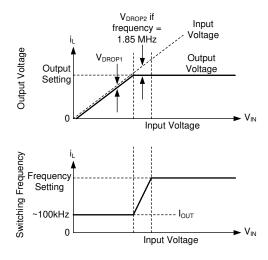


In valley control mode, the minimum inductor current is regulated, not peak inductor current.

图 8-22. Valley Current Mode Operation

#### 8.4.3.5 Dropout

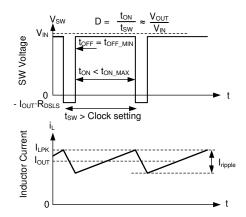
Dropout operation is defined as any input-to-output voltage ratio that requires frequency to drop to achieve the needed duty factor. At a given clock frequency, duty factor is limited by minimum off-time. Once this limit is reached, if clock frequency is maintained, output voltage falls. Instead of allowing the output voltage to drop, the LM6x4xx extends on-time past the end of the clock cycle until the required peak inductor current is achieved. The clock can start a new cycle once peak inductor current is achieved or once a pre-determined maximum on-time,  $t_{ON\_MAX}$ , of approximately 9  $\mu$ s passes. As a result, once the needed duty factor cannot be achieved at the selected clock frequency due to the existence of a minimum off-time, frequency drops to maintain regulation. If input voltage is low enough that the output voltage cannot be regulated even with an on-time of  $t_{ON\_MAX}$ , output voltage drops to slightly below input voltage,  $v_{DROP1}$ . See  $v_{DROP1}$ . See



Output voltage and frequency versus input voltage: If there is little difference between input voltage and output voltage setting, the IC reduces frequency to maintain regulation. If input voltage is too low to provide the desired output voltage at approximately 110 kHz, output voltage tracks input voltage.

图 8-23. Frequency and Output Voltage in Dropout





This image shows the switching waveforms while in dropout. Inductor current takes longer than a normal clock to reach the desired peak value. As a result, frequency drops. This frequency drop is limited by t<sub>ON MAX</sub>.

#### 图 8-24. Dropout Waveforms

### 8.4.3.6 Recovery from Dropout

In some applications, input voltage can drop below the desired output voltage then recover to a higher value suddenly. With most regulators, the sudden increase in input voltage results in output voltage rising at a rate limited only by current limit until regulation is achieved. As input voltage reaches the desired output voltage, there is overshoot due to wind up in the control loop. This overshoot can be large in applications that have small output capacitors and light loads. Also, large inrush currents can cause large fluctuations on the input line once the regulator starts regulating the output voltage. This typically requires less current than during this initial inrush.

The LM6x4xx greatly reduces inrush current and overshoot. This is done by engaging the soft-start circuit whenever the input voltage suddenly rises, after dipping low enough to cause the output voltage to droop. To prevent this feature from accidently engaging, output voltage must rise more than 1% to engage this feature. Also, this feature engages only if operating in dropout or current limit, preventing interference with normal transient response but allowing several percent overshoot while engaging. If output voltage is very close to its desired level, overshoot is reduced by inductor current not having time to rise to a high level before regulation starts.

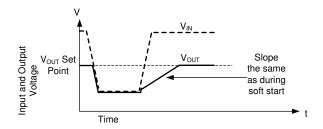


图 8-25. When Output Voltage Falls, It Recovers Slowly Preventing Overshoot and Large Inrush Currents

### 8.4.3.7 Other Fault Modes

Fault modes and their description can be found in # 8.3 of this data sheet.



### 9 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Application Information

The LM6x4xx step-down DC-to-DC converter is typically used to convert a higher DC voltage to a lower DC voltage with a maximum output current of 10 A. If run at 400 kHz, 10 A can be sustained continuously. If run at 2.2 MHz, continuous current must be limited to 6 A if ambient temperature is 105°C. The following design procedure can be used to select components for the LM6x4xx.

### 9.2 Typical Application

图 9-1 shows a typical application circuit for the LM6x4xx. This device is designed to function over a wide range of external components and system parameters. However, the internal compensation is optimized for a certain range of external inductance and output capacitance. As a quick start guide, 表 9-2 provides typical component values for some of the most common configurations. The values given in the table are typical. Other values can be used to enhance certain performance criterion as required by the application. Note that for this QFN package, the input capacitors are split and placed on either side of the package. See # 9.2.2.5 for more details.

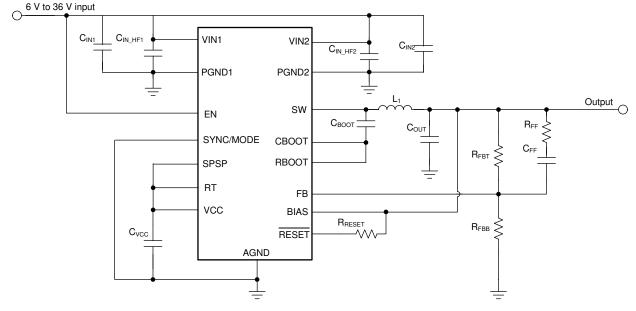


图 9-1. Example Application Circuit - 400-kHz Adjustable Output



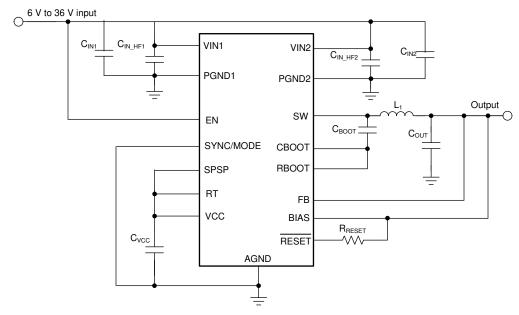


图 9-2. Example Application Circuit - 400-kHz Fixed Output

### 9.2.1 Design Requirements

表 9-1 provides the parameters for our detailed design procedure example:

表 9-1. Detailed Design Parameters

DESIGN PARAMETER	EXAMPLE VALUE
Input voltage	13.5 V (6 V to 36 V)
Output voltage	5 V
Maximum output current	10 A continuous
Switching frequency	400 kHz

表 9-2. Typical External Component Values

f <sub>SW</sub>	V <sub>OUT</sub> (V)	1.1 (uH)	C <sub>OUT</sub> (RATED)	R <sub>FBT</sub>	R <sub>FBB</sub>	C <sub>IN</sub> +	C <sub>BOOT</sub>	R <sub>BOOT</sub>	C <sub>VCC</sub>	C <sub>FF</sub> (pF)	R <sub>FF</sub>
(kHz)	1001 (1)	(μ. ι.)	5001 (.04125)	(kΩ)	(kΩ)	C <sub>HF</sub> (µF)	(μ <b>F</b> )	(Ω)	(μF)	-FF (Pi )	(kΩ)
400	5	3.0	3 × 47 μF ceramic or 2 x 22 μF + 15 mΩ 150 μF	100	24.9	2 x 10 + 2 x 0.47	0.1	0	1	10	4.99
400	3.3	2.4	3 × 47 μF ceramic or 2 x 22 μF + 15 mΩ 150 μF	100	43.2	2 x 10 + 2 x 0.47	0.1	0	1	10	4.99

### 9.2.2 Detailed Design Procedure

The following design procedure refers to 图 9-1 and 表 9-1.

#### 9.2.2.1 Choosing the Switching Frequency

The choice of switching frequency is a compromise between conversion efficiency and overall solution size. Lower switching frequency implies reduced switching losses, usually resulting in less power dissipated in the IC. Lower power dissipated in the IC results in higher system efficiency and a lower IC temperature. However, higher switching frequency allows the use of smaller inductors and output capacitors, hence, a more compact design. Many applications require that the AM band be avoided. These applications tend to operate at either 400 kHz below the AM band, or 2.2 MHz above the AM band. In this example, 400 kHz is chosen.

#### 9.2.2.2 Setting the Output Voltage

The output voltage of the LM6x4xx is externally adjustable using a resistor divider network. Two recommended output voltages are found in  $\frac{1}{5}$  9-2. The divider network is comprised of the top and bottom feedback resistors,  $R_{FBT}$  and  $R_{FBB}$ , and closes the loop between the output voltage and the converter. The converter regulates the

output voltage by holding the voltage on the FB pin equal to the internal reference voltage,  $V_{REF}$  = 1 V. The total resistance of the divider is a compromise between excessive noise pickup and excessive loading of the output. Lower resistance values reduce noise sensitivity but also reduce the light-load efficiency. The recommended value for  $R_{FBT}$  is 100 k $\Omega$  with a maximum value of 1 M $\Omega$ . If 1 M $\Omega$  is selected for  $R_{FBT}$ , then a feedforward capacitor  $C_{FF}$  must be used across this resistor to provide adequate loop phase margin (see #9.2.2.9). Once  $R_{FBT}$  is selected, 方程式 1 is used to select  $R_{FBB}$ .  $V_{REF}$  is nominally 1 V. For this 5-V example,  $R_{FBT}$  = 100 k $\Omega$  and  $R_{FBB}$  = 24.9 k $\Omega$ .

#### 9.2.2.3 Inductor Selection

The main parameters for selecting the inductor are the inductance and saturation current. The inductance is based on the desired peak-to-peak ripple current. It is normally chosen to be in the range of 20% to 40% of the maximum output current. Experience shows that the best value for inductor ripple current is 30% of the maximum load current for systems with a fixed input voltage. For systems with a variable input voltage such as the 12-V battery in a car, 25% is the best value. This example uses  $V_{IN}$  = 13.5 V, which is closer to the nominal voltage of a 12-V car battery. When selecting the ripple current for applications with much smaller maximum load than the maximum available from the device, the maximum device current must still be used for this calculation. 方程式 5 can be used to determine the value of the inductance. The constant K is the percentage of peak-to-peak inductor current ripple to rated output current. For this 10-A, 400-kHz, 5-V example, K = 0.25 is chosen and an inductance of approximately 3.15 μH is found. The closest standard value of 3.0 μH was selected.

$$L = \frac{V_{IN} - V_{OUT}}{f_{SW} \cdot K \cdot I_{OUT}(MAX)} \cdot \frac{V_{OUT}}{V_{IN}}$$
(5)

Ideally, the saturation current rating of the inductor must be at least as large as the high-side switch current limit,  $I_{SC}$ . This ensures that the inductor does not saturate, even during a soft-short condition on the output. A hard short causes the LM6x4xx to enter hiccup mode (see # 8.3.13). A soft short can hold the output current at current limit without triggering hiccup. When the inductor core material saturates, the inductance falls to a very low value, causing the inductor current to rise very rapidly. Although the valley current limit,  $I_{LS-LIMIT}$ , is designed to reduce the risk of current runaway, a saturated inductor can cause the current to rise to high values very rapidly. This can lead to component damage, so it is crucial that the inductor does not saturate. Inductors with a ferrite core material have very hard saturation characteristics, but usually have lower core losses than powdered iron cores. Powered iron cores exhibit a soft saturation, allowing some relaxation in the current rating of the inductor. However, they have more core losses at frequencies typically above 1 MHz. In any case, the inductor saturation current must not be less than the device high-side current limit,  $I_{SC}$ . To avoid subharmonic oscillation, the inductance value must not be less than that given in  $\cancel{5}$   $\cancel{5}$ 

$$L \ge 0.19 \times \frac{V_{OUT}}{f_{SW}} \tag{6}$$

#### 9.2.2.4 Output Capacitor Selection

The output capacitor value and ESR determine the output voltage ripple and load transient performance. The output capacitor is usually limited by the load transient requirements rather than the output voltage ripple.  $\frac{1}{2}$  can be used to find capacitor values for  $C_{OUT}$  and  $C_{FF}$  for a few common applications. Note that 4.99-kΩ  $R_{FF}$  must be used in series with  $C_{FF}$ . In this example, good transient performance is desired, giving 3 x 47-μF ceramic as the output capacitor and 10 pF as  $C_{FF}$ .



表 9-3. Selected Output Capacitor and C <sub>FF</sub> Values	表 9-3.	Selected	Output	Capacitor	and CFF	<b>Values</b>
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	SIZE	TRANSIENT	3.3-V OUTPUT	3.3-V OUTPUT 5-V OUTPUT		
FREQUENCY	VERSUS COST	PERFORMANCE	C <sub>OUT</sub>	C <sub>FF</sub>	Соит	C <sub>FF</sub>
400 kHz	Small size	Minimum	3 x 47-μF ceramic	10 pF	4 x 33-μF ceramic	10 pF
400 kHz	Small size	Better Transient	4 x 47-μF ceramic	33 pF	3 x 47-μF ceramic	33 pF
400 kHz	Low cost	Minimum	3 x 22-μF ceramic + 1 x 150 μF, 15 mΩ electrolytic	10 pF	2 x 22-μF ceramic + 1 x 150 μF, 15 mΩ electrolytic	10 pF
400 kHz	Low cost	Better Transient	3 x 22-μF ceramic + 1 x 220 μF, 15 mΩ electrolytic	33 pF	2 x 22-μF ceramic + 1 x 220 μF, 15 mΩ electrolytic	22 pF

#### 9.2.2.5 Input Capacitor Selection

The ceramic input capacitors provide a low impedance source to the regulator in addition to supplying the ripple current and isolating switching noise from other circuits. A minimum of 10-μF ceramic capacitance is required on the input of the LM6x4xx. This must be rated for at least the maximum input voltage that the application requires. It is preferable to have twice the maximum input voltage to reduce DC bias derating. This capacitance can be increased to help reduce input voltage ripple and maintain the input voltage during load transients. In addition, a small case size (0603 or 0402) ceramic capacitor must be used at each input/ground pin pair, VIN1/PGND1 and VIN2/PGND2, immediately adjacent to the regulator. The capacitor must have a voltage rating of at least double the maximum input voltage to minimize derating. The capacitor must also have an X7R or better dielectric. Choose the highest capacitor value with these parameters. This provides a high frequency bypass to reduce switch-node ring and electromagnetic interference emissions. The QFN (RJR) package provides two input voltage pins and two power ground pins on opposite sides of the package. This allows the input capacitors to be split and placed optimally with respect to the internal power MOSFETs, thus improving the effectiveness of the input bypassing. This example places two 10-μF, 50-V, 1206, X7R ceramic capacitors and two 0.47-μF, 50-V, 0603, X7R ceramic capacitors at each VIN/PGND pin pair.

Often, it is desirable to use an electrolytic capacitor on the input in parallel with the ceramics. This is especially true if long leads/traces are used to connect the input supply to the regulator. The moderate ESR of this capacitor can help damp ringing on the input supply caused by the inductance of the long power leads. The use of this additional capacitor also helps with momentary voltage dips caused by input supplies with unusually high impedance.

Most of the input switching current passes through the ceramic input capacitors. The approximate worst case RMS value of this current can be calculated with 方程式 7. This value must be checked against the manufacturers' maximum ratings.

$$I_{RMS} \approx \frac{I_{OUT}}{2}$$

(7)

### 9.2.2.6 BOOT Capacitor

The LM6x4xx requires a bootstrap capacitor connected between the CBOOT pin and the SW pin. This capacitor stores energy which is used to supply the gate drivers for the power MOSFETs. A high-quality 100-nF ceramic capacitor with a rating of at least 10 V is required. The package provides space between the VIN2 and RBOOT pins to route SW to the boot capacitor without needing long traces or multi-layer routing.

#### 9.2.2.7 BOOT Resistor

A BOOT resistor can be connected between the CBOOT and RBOOT pins to slow the rise-time of the SW node. If EMI performance is not critical, these two pins can be shorted. If EMI is critical, use a 0- $\Omega$  placeholder. The value can be increased if additional EMI margin is required. Increase to 200  $\Omega$  as a first step. This slows the rise-time of the SW node, reducing EMI by hundreds of MHz by a few dB $\mu$ V. This is at the expense of about 0.3% efficiency at 400 kHz at 10 A. Use 50  $\Omega$  for a similar efficiency drop at 2.2 MHz at 6 A. In this example, 0  $\Omega$  is chosen to maximize efficiency.



#### 9.2.2.8 VCC

The VCC pin is the output of the internal LDO used as a supply to the internal control circuits of the regulator. This output requires a 1- $\mu$ F, 16-V, X7R or similar, 0603 or similar ceramic capacitor connected from VCC to AGND for proper operation. Generally avoid loading this output with any external circuitry. However, this output can be used to supply the pullup for the RESET (power-good) function (see #8.3.6). A pullup resistor with value of 100 k $\Omega$  is a good choice in this case. The nominal output voltage on VCC is 3.3 V. Do not short this output to ground or any other external voltage.

#### 9.2.2.9 C<sub>FF</sub> and R<sub>FF</sub> Selection

A feedforward capacitor,  $C_{FF}$ , is used to improve phase margin and transient response of circuits, which have output capacitors with low ESR. Since this capacitor can conduct noise from the output of the circuit directly to the FB node of the IC, a 4.99-k $\Omega$  resistor,  $R_{FF}$ , must be placed in series with  $C_{FF}$ . If the ESR zero of the output capacitor is below 200 kHz, no  $C_{FF}$  must be used.

If output voltage is less than 2.5 V,  $C_{FF}$  has little effect, so it can be omitted. If output voltage is greater than 14 V,  $C_{FF}$  must be used cautiously since it can easily introduce too much gain at higher frequencies.

If 1 M $\Omega$  is selected for R<sub>FBT</sub>, then a feedforward capacitor C<sub>FF</sub> must be used.

### 9.2.2.10 R<sub>SPSP</sub> Selection

#### 9.2.2.11 R<sub>T</sub> Selection

The R<sub>T</sub> resistor sets the switching frequency of the converter. See # 8.3.5 for more details. A resistor value of 40.2 k $\Omega$  corresponds to 400 kHz. The pin is also configured to set the switching frequency at 400 kHz when the RT pin is connected to VCC. Connecting the RT pin to VCC allows you to save cost and space, but placing a 40.2-k resistor allows for more flexibility if a different frequency is desired at a later time.

### 9.2.2.12 R<sub>MODE</sub> Selection

The SYNC/MODE pin allows you to synchronize the converter to an external clock with an external clock signal (SYNC). The pin also allows the selection between two modes (MODE). The following are the selectable modes:

- Forced pulse width modulation (FPWM) operation, which operates at a fixed frequency at all times
- · Auto mode which automatically switches to pulse-frequency modulation (PFM) at light loads

Connect the SYNC/MODE pin to VCC for FPWM. Connect to GND for auto. You can also apply a clock signal to synchronize the switching frequency to an external clock. See # 8.3.3 for more information.

### 9.2.2.13 External UVLO

In some cases, you need an input undervoltage lockout (UVLO) level different than that provided internal to the device. This can be accomplished by using the circuit shown in 图 9-3. The input voltage at which the device turns on is designated  $V_{ON}$  while the turnoff voltage is  $V_{OFF}$ . First, a value for  $R_{ENB}$  is chosen in the range of 10  $k\Omega$  to 100  $k\Omega$ , then 方程式 8 is used to calculate  $R_{ENT}$  and  $V_{OFF}$ .

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(8)



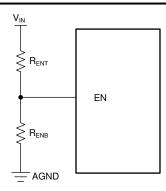


图 9-3. UVLO Using EN

$$R_{ENT} = \left(\frac{V_{ON}}{V_{EN}} - 1\right) \cdot R_{ENB}$$

 $V_{OFF} = V_{ON} \cdot (1 - V_{EN-HYST})$ 

#### where

- V<sub>ON</sub> = V<sub>IN</sub> turnon voltage
- V<sub>OFF</sub> = V<sub>IN</sub> turnoff voltage

### 9.2.2.14 Maximum Ambient Temperature

As with any power conversion device, the LM6x4xx dissipates internal power while operating. The effect of this power dissipation is to raise the internal temperature of the converter above ambient temperature. The internal die temperature (T<sub>J</sub>) is a function of the following:

- Ambient temperature
- Power loss
- Effective thermal resistance, R<sub>θJA</sub> of the device
- PCB combination

The maximum internal die temperature for the LM6x4xx must be limited to  $150^{\circ}$ C. This establishes a limit on the maximum device power dissipation and, therefore, the load current. 方程式 9 shows the relationships between the important parameters. Larger ambient temperatures ( $T_A$ ) and larger values of  $R_{\theta JA}$  reduce the maximum available output current. The converter efficiency can be estimated by using the curves provided in this data sheet. If the desired operating conditions cannot be found in one of the curves, then interpolation can be used to estimate the efficiency. Alternatively, the EVM can be adjusted to match the desired application requirements and the efficiency can be measured directly. The correct value of  $R_{\theta JA}$  is more difficult to estimate. As stated in the Semiconductor and IC Package Thermal Metrics Application Report, the value of  $R_{\theta JA}$  given in the Thermal Information is not valid for design purposes and must not be used to estimate the thermal performance of the application. The values reported in the Thermal Information table were measured under a specific set of conditions that are rarely obtained in an actual application.

$$I_{OUT}|_{MAX} = \frac{\left(T_{J} - T_{A}\right)}{R_{\theta JA}} \cdot \frac{\eta}{\left(1 - \eta\right)} \cdot \frac{1}{V_{OUT}}$$
(9)

#### where

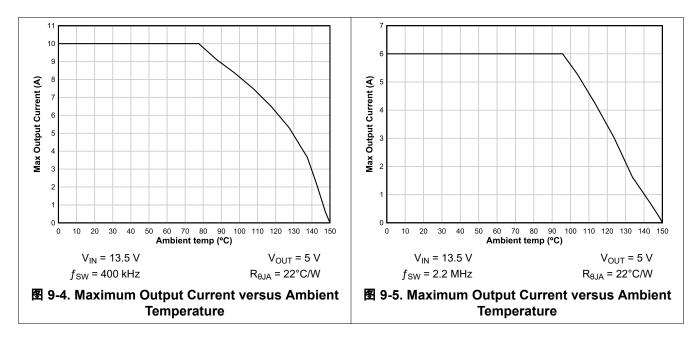
- η = efficiency
- T<sub>A</sub> = ambient temperature
- T<sub>J</sub> = junction temperature
- R<sub>θJA</sub> = the effective thermal resistance of the IC junction to the air, mainly through the PCB



The effective  $R_{\theta JA}$  is a critical parameter and depends on many factors (just to mention a few of the most critical parameters:

- · Power dissipation
- · Air temperature
- Airflow
- PCB area
- Copper heat-sink area
- Number of thermal vias under or near the package
- · Adjacent component placement

Due to the ultra-miniature size of the VQFN (RNX) package, a DAP is not available, requiring most of the heat to flow from the pins to the board. This means that this package exhibits a somewhat large  $R_{\theta JA}$  value when the layout does not allow for heat to flow from the pins. A typical curve of maximum output current versus ambient temperature is shown in Maximum Output Current versus Ambient Temperature and Maximum Output Current versus Ambient Temperature for a good thermal layout. This data was taken with a device and PCB combination, giving an  $R_{\theta JA}$  of about 22°C/W. It must be remembered that the data given in these graphs are for illustration purposes only, and the actual performance in any given application depends on all of the previously mentioned factors.

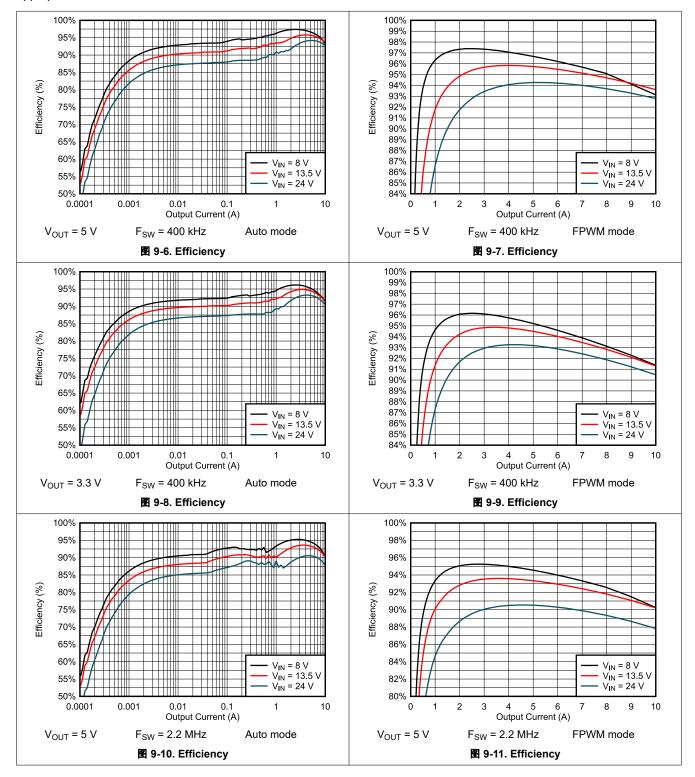


Use the following resources as a guide to optimal thermal PCB design and estimating  $R_{\theta JA}$  for a given application environment:

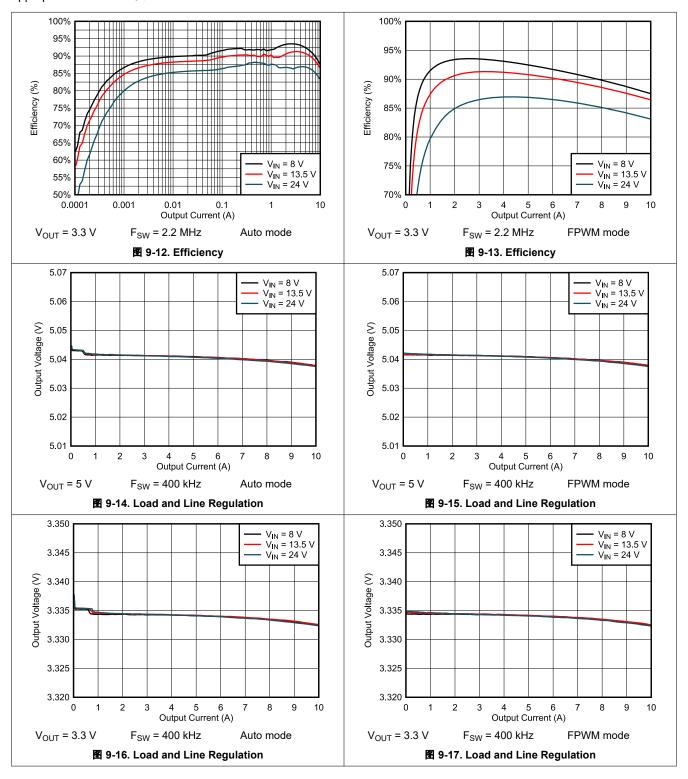
- Thermal Design by Insight not Hindsight
- A Guide to Board Layout for Best Thermal Resistance for Exposed Pad Packages
- Semiconductor and IC Package Thermal Metrics
- Thermal Design Made Simple with LM43603 and LM43602
- PowerPAD™ Thermally Enhanced Package
- PowerPAD™ Made Easy
- Using New Thermal Metrics



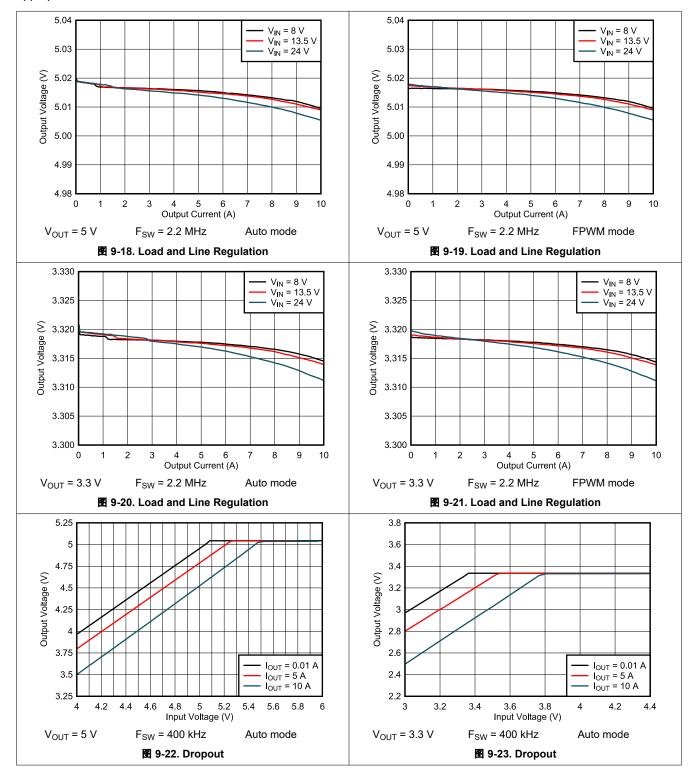
### 9.2.3 Application Curves













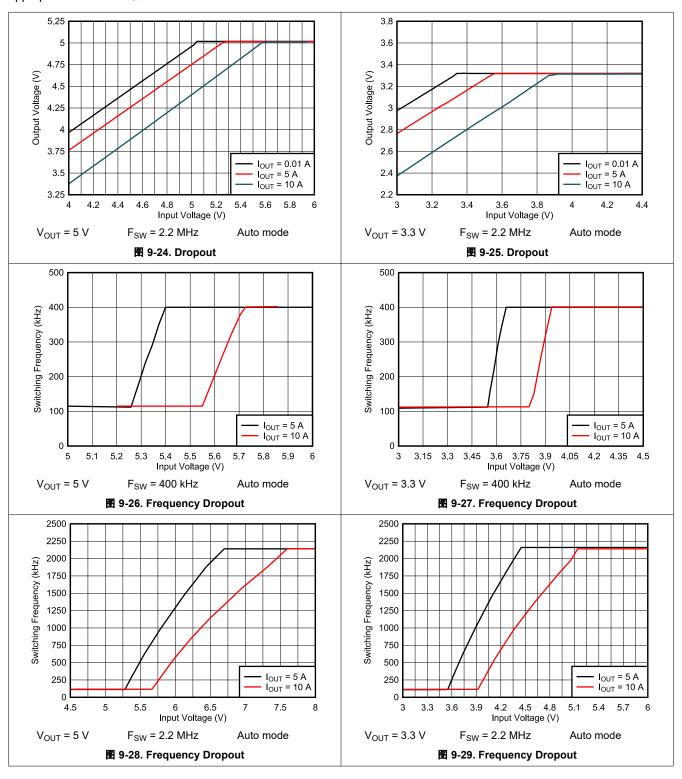




表 9-4. BOM for Typical Application Curves

V <sub>OUT</sub>	FREQUENCY	R <sub>FBB</sub>	C <sub>OUT</sub>	C <sub>IN</sub> + C <sub>HF</sub>	L	C <sub>FF</sub>
3.3 V	400 kHz	43.2 kΩ	6 x 22 μF	2 × 4.7 µF + 2 × 470 nF	2.4 µH	22 pF
3.3 V	2100 kHz	43.2 kΩ	4 x 22 μF	2 × 4.7 µF + 2 × 470 nF	0.68 µH	10 pF
5 V	400 kHz	24.9 kΩ	6 x 22 μF	2 × 4.7 µF + 2 × 470 nF	2.4 µH	22 pF
5 V	2100 kHz	24.9 kΩ	4 x 22 μF	2 × 4.7 µF + 2 × 470 nF	0.68 µH	10 pF



# 10 Power Supply Recommendations

The characteristics of the input supply must be capable of delivering the required input current to the loaded regulator. The average input current can be estimated with 方程式 10.

$$I_{IN} = \frac{V_{OUT} \cdot I_{OUT}}{V_{IN} \cdot \eta}$$
(10)

where

• η is the efficiency

If the regulator is connected to the input supply through long wires or PCB traces, special care is required to achieve good performance. The parasitic inductance and resistance of the input cables can have an adverse effect on the operation of the regulator. The parasitic inductance, in combination with the low-ESR ceramic input capacitors, can form an underdamped resonant circuit. This can result in overvoltage transients at the input to the regulator or tripping UVLO. Consider that the supply voltage can dip when a load transient is applied to the output depending on the parasitic resistance and inductance of the harness and characteristics of the supply. If the application is operating close to the minimum input voltage, this dip can cause the regulator to momentarily shut down and reset. The best way to solve these kinds of issues is to reduce the distance from the input supply to the regulator. Additionally, use an aluminum input capacitor in parallel with the ceramics. The moderate ESR of this type of capacitor helps damp the input resonant circuit and reduce any overshoots or undershoots. A value in the range of 20  $\mu$ F to 100  $\mu$ F is usually sufficient to provide input damping and help hold the input voltage steady during large load transients.

In some cases, a transient voltage suppressor (TVS) is used on the input of regulators. One class of this device has a snap-back characteristic (thyristor type). It is not recommended to use a device with this type of characteristic. When the TVS fires, the clamping voltage falls to a very low value. If this voltage is less than the output voltage of the regulator, the output capacitors discharge through the device back to the input. This uncontrolled current flow can damage the device.

The input voltage must not be allowed to fall below the output voltage. In this scenario, such as a shorted input test, the output capacitors discharge through the internal parasitic diode found between the VIN and SW pins of the device. During this condition, the current can become uncontrolled, possibly causing damage to the device. If this scenario is considered likely, then use a Schottky diode between the input supply and the output.



# 11 Layout

# 11.1 Layout Guidelines

The PCB layout of any DC-DC converter is critical to the optimal performance of the design. Bad PCB layout can disrupt the operation of an otherwise good schematic design. Even if the converter regulates correctly, bad PCB layout can mean the difference between a robust design and one that cannot be mass produced. Furthermore, the EMI performance of the regulator is dependent on the PCB layout to a great extent. In a buck converter, the most EMI-critical PCB feature is the loop formed by the input capacitor or capacitors and power ground. This is shown in 11-1. This loop carries large transient currents that can cause large transient voltages when reacting with the trace inductance. Excessive transient voltages can disrupt the proper operation of the converter. Because of this, the traces in this loop must be wide and short while keeping the loop area as small as possible to reduce the parasitic inductance. 11-2 shows a recommended layout for the critical components of the LM6x4xx circuit.

- Place the input capacitor or capacitors as close as possible to the input pin pairs: VIN1 to PGND1 and VIN2 to PGND2. Place the small capacitors closest. Each pair of pins are adjacent, simplifying the input capacitor placement. With the QFN package, there are two VIN/PGND pairs on either side of the package. This provides for a symmetrical layout and helps minimize switching noise and EMI generation. Use a wide VIN plane on a lower layer to connect both of the VIN pairs together to the input supply.
- Place the bypass capacitor for VCC close to the VCC pin and AGND pins: This capacitor must be routed with short, wide traces to the VCC and AGND pins.
- Place the CBOOT capacitor as close as possible to the device with short, wide traces to the CBOOT
  and SW pins: It is important to route the SW connection under the device through the gap between VIN2 and
  RBOOT pins, reducing exposed SW node area. If an RBOOT resistor is used, place it as close as possible
  to the CBOOT and RBOOT pins. If high efficiency is desired, RBOOT and CBOOT pins can be shorted. This
  short must be placed as close as possible to the RBOOT and CBOOT pins.
- Place the feedback divider as close as possible to the FB pin of the device: Place R<sub>FBB</sub>, R<sub>FBT</sub>, C<sub>FF</sub> if used, and R<sub>FF</sub> if used, physically close to the device. The connections to FB and AGND through R<sub>FBB</sub> must be short and close to those pins on the device. The connection to V<sub>OUT</sub> can be somewhat longer. However, this latter trace must not be routed near any noise source (such as the SW node) that can capacitively couple into the feedback path of the regulator.
- Layer 2 of the PCB must be a ground plane: This plane acts as a noise shield and as a heat dissipation
  path. Using layer 2 reduces the inclosed area in the input circulating current in the input loop, reducing
  inductance.
- **Provide wide paths for V<sub>IN</sub>, V<sub>OUT</sub>, and GND**: These paths must be as wide and direct as possible to reduce any voltage drops on the input or output paths of the converter to maximize efficiency.
- Provide enough PCB area for proper heat sinking: Enough copper area must be used to ensure a
  low R<sub>0JA</sub>, considering maximum load current and ambient temperature. Make the top and bottom PCB
  layers with two-ounce copper and no less than one ounce. If the PCB design uses multiple copper layers
  (recommended), thermal vias can also be connected to the inner layer heat-spreading ground planes. Note
  that the package of this device dissipates heat through all pins. Wide traces must be used for all pins except
  where noise considerations dictate minimization of area.
- **Keep switch area small**: Keep the copper area connecting the SW pin to the inductor as short and wide as possible. At the same time, the total area of this node must be minimized to help reduce radiated EMI.



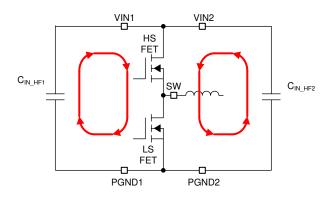


图 11-1. Input Current Loop

#### 11.1.1 Ground and Thermal Considerations

As mentioned above, TI recommends using one of the middle layers as a solid ground plane. A ground plane provides shielding for sensitive circuits and traces. It also provides a quiet reference potential for the control circuitry. The AGND and PGND pins must be connected to the ground planes using vias next to the bypass capacitors. PGND pins are connected directly to the source of the low-side MOSFET switch, and connect directly to the grounds of the input and output capacitors. The PGND net contains noise at the switching frequency and can bounce due to load variations. The PGND trace, as well as the VIN and SW traces, must be constrained to one side of the ground plane. The other side of the ground plane contains much less noise and must be used for sensitive traces.

TI recommends providing adequate device heat sinking by using vias near ground and  $V_{\text{IN}}$  to connect to the system ground plane or  $V_{\text{IN}}$  strap, both of which dissipate heat. Use as much copper as possible for the system ground plane on the top and bottom layers for the best heat dissipation. Use a four-layer board with the copper thickness for the four layers, starting from the top as: 2 oz / 1 oz / 2 oz. A four-layer board with enough copper thickness and proper layout provides low current conduction impedance, proper shielding, and lower thermal resistance.



# 11.2 Layout Example

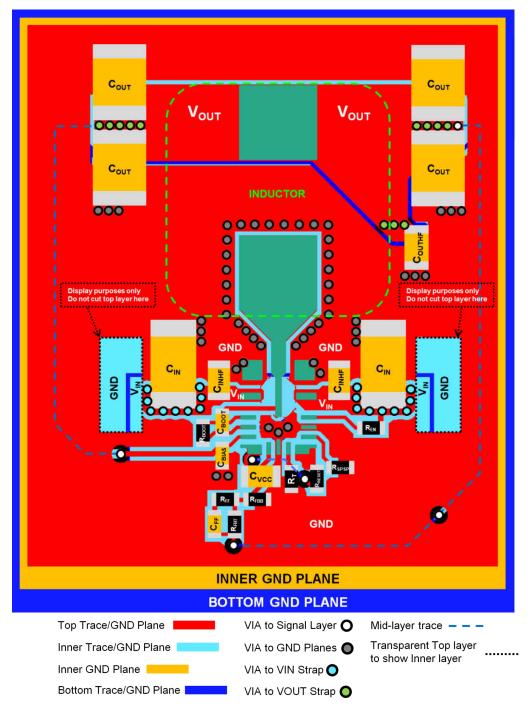


图 11-2. Layout Example



# 12 Device and Documentation Support

## 12.1 Device Support

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# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



# PACKAGE OPTION ADDENDUM

9-Mar-2021

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LM61480RPHR	PREVIEW	VQFN-HR	RPH	16	3000	Non-RoHS & Non-Green	Call TI	Call TI	-40 to 150		
LM61495RPHR	PREVIEW	VQFN-HR	RPH	16	3000	Non-RoHS & Non-Green	Call TI	Call TI	-40 to 150		
LM62460RPHR	PREVIEW	VQFN-HR	RPH	16	3000	Non-RoHS & Non-Green	Call TI	Call TI	-40 to 150		

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